

# Non Evaporable Getter thin films for Particles Accelerators

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## Outline

1. Introduction
2. NEG properties and performances
3. Production of NEG coatings
4. “Application to synchrotron light sources”
5. Summary & final remarks

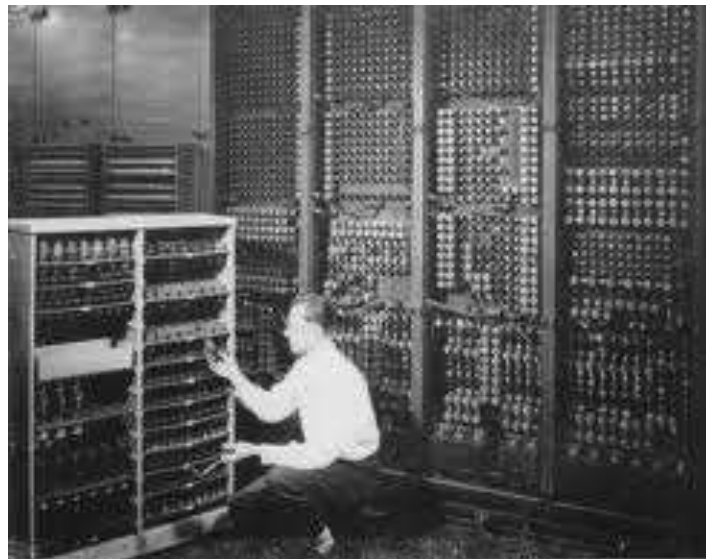
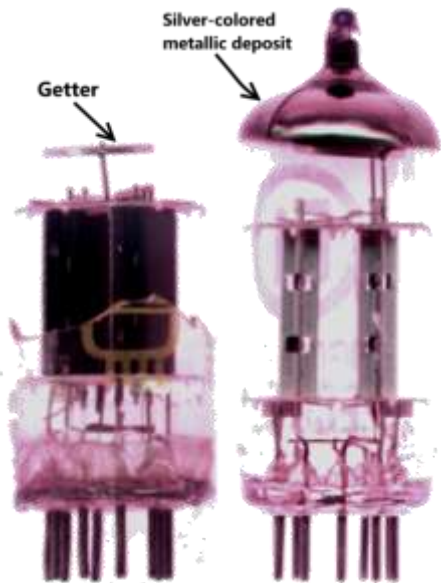
# 1 - Introduction

Getters are materials capable of chemically adsorbing gas molecules (by chemisorption). To do so, their surface must be clean.

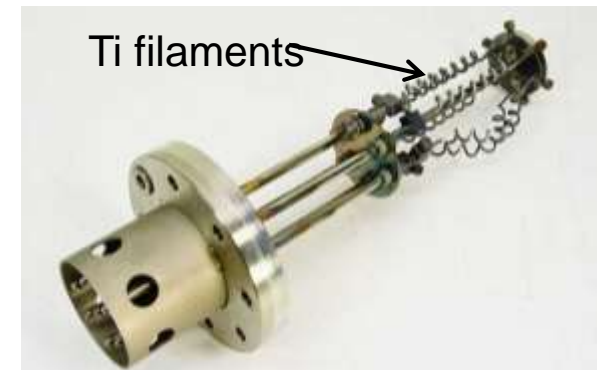
In situ deposition of a fresh getter film (under vacuum)



## *Evaporable Getters*



Replacing a bad tube meant checking among ENIAC's 19,000 possibilities.



# 1 - Introduction

Getters are materials capable of chemically adsorbing gas molecules (by chemisorption). To do so, their surface must be clean.

In situ deposition of a fresh getter film (under vacuum)



***Evaporable Getters***

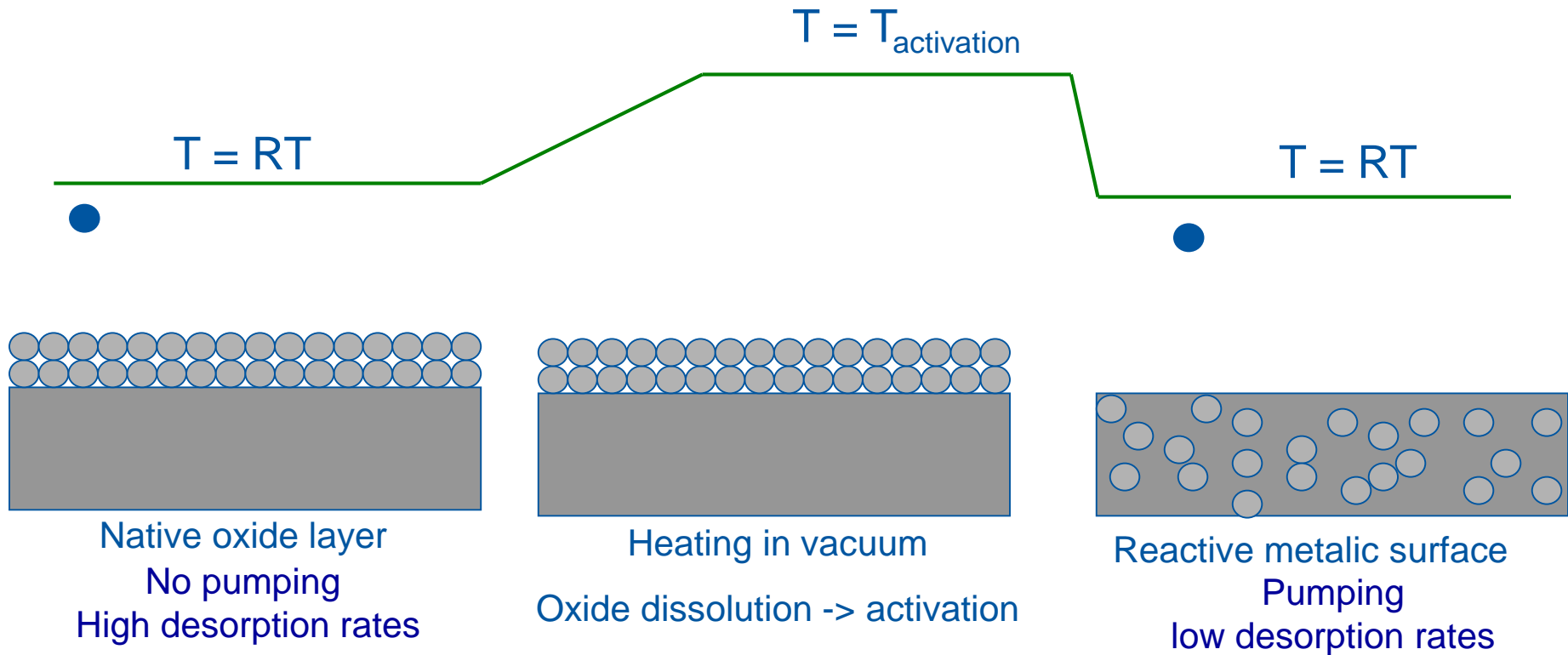
Diffusion of the oxide layer into the bulk (usually by heating in vacuum to ***the activation temperature***)



***Non Evaporable Getters  
(NEG)***

# 1 - Introduction

## Activation temperature of a NEG

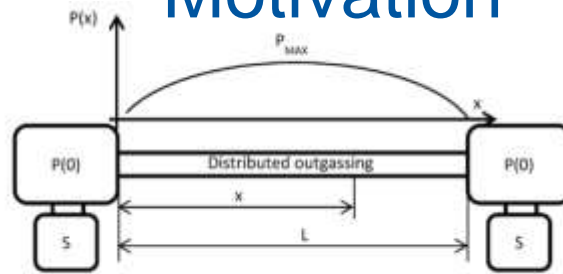


NEG pumps most of the gases except noble gases and methane at room temperature

# 1 - Introduction

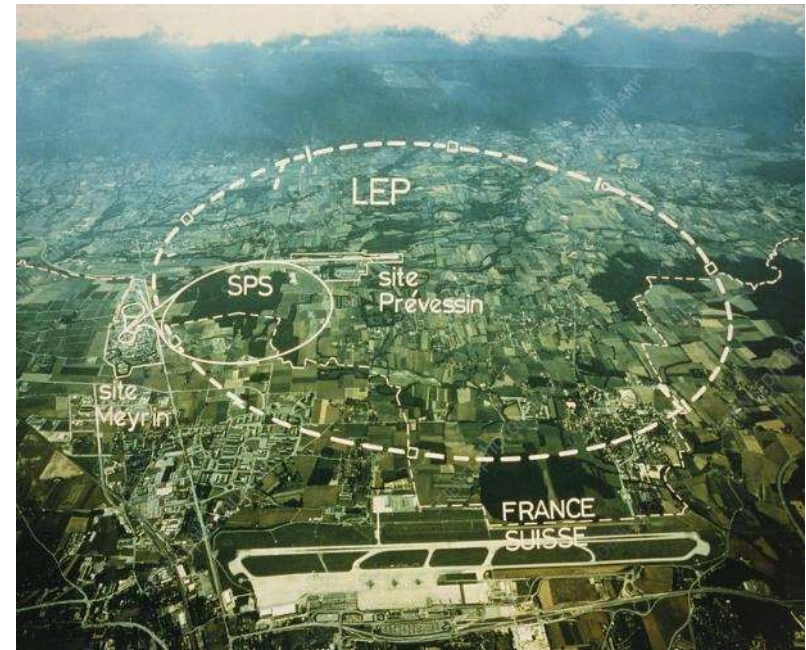
## Distributed Pumping in long beam pipes

## Motivation



$$P_{max} = P(0) + \frac{Q_{total}}{8C}$$

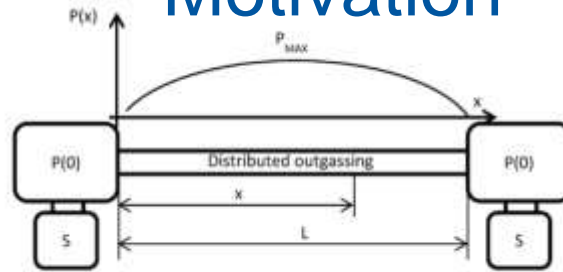
Fig. 11: Pressure profile in a tube pumped at both extremities with uniformly distributed outgassing rate



# 1 - Introduction

## Distributed Pumping in long beam pipes

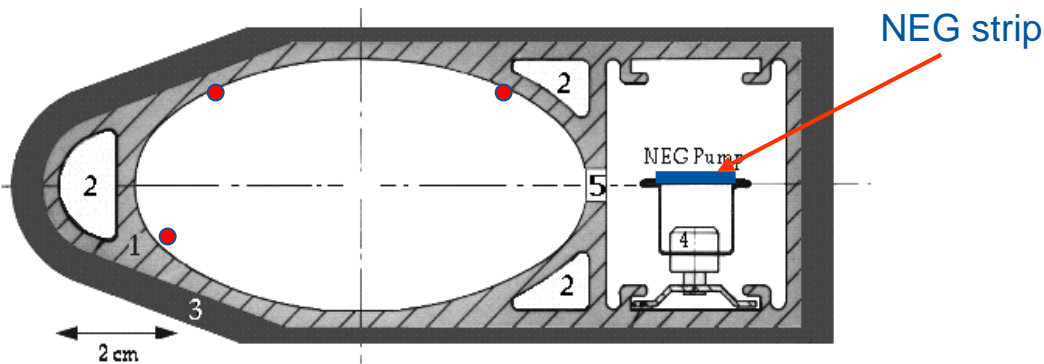
## Motivation



$$P_{max} = P(0) + \frac{Q_{total}}{8C}$$

Fig. 11: Pressure profile in a tube pumped at both extremities with uniformly distributed outgassing rate

## Cross section of the LEP dipole vacuum chamber



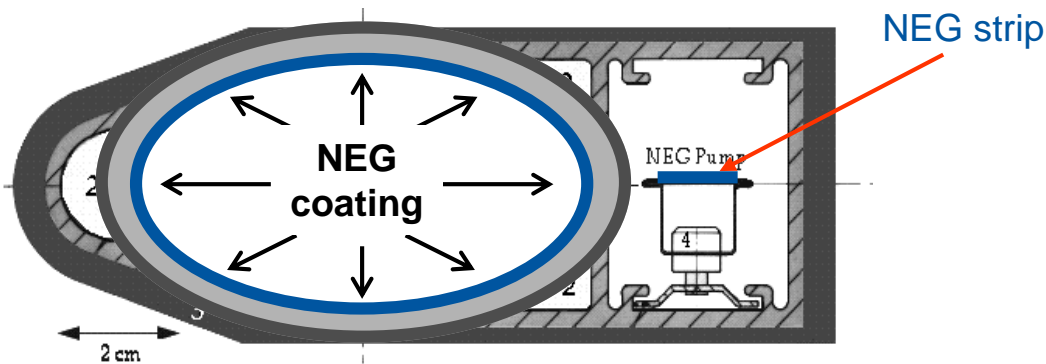
# 1 - Introduction

## Motivation

Distributed Pumping  
in long beam pipes

Transform the vacuum  
chamber into a pump

Low induced outgassing  
Low secondary electron yield

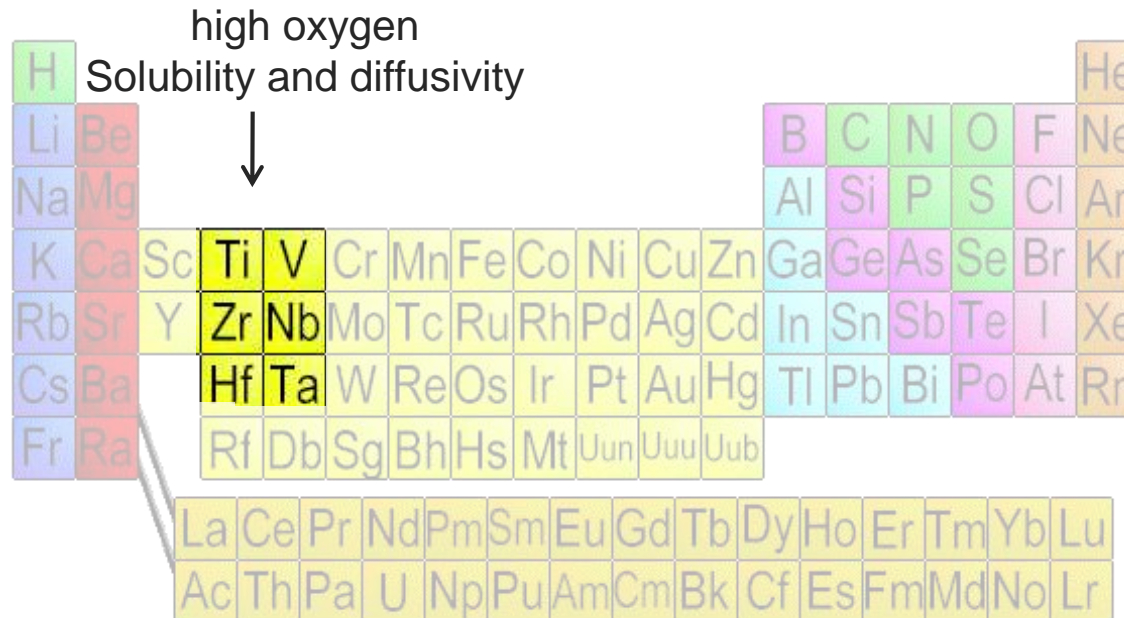


**Cristoforo Benvenuti**



# 2 – NEG properties & performances

## NEG materials:



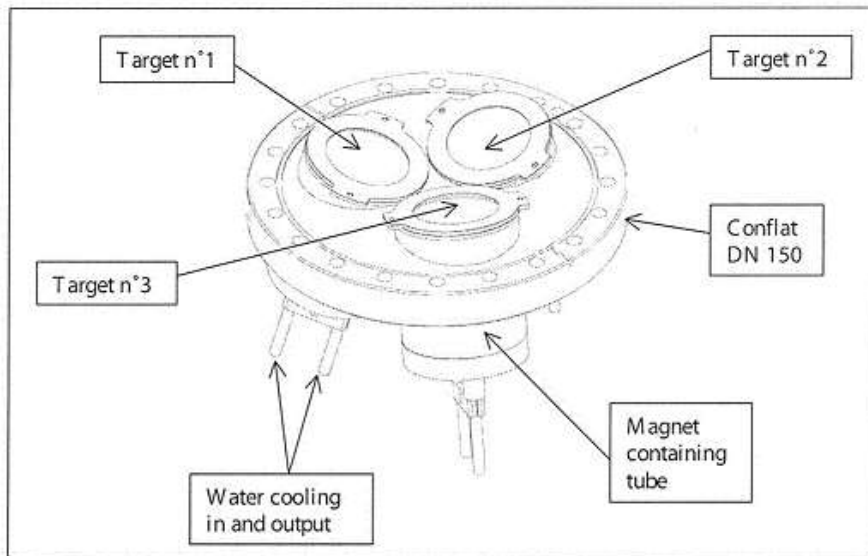
# 2 – NEG properties & performances

## NEG materials:

NEG coatings have been produced by Magnetron Sputtering of elements and alloys from the IV and V group of the periodic table.

More than 20 materials were investigated by combining 2 or 3 of this elements in the form of thin films.

The thin films were produced in a triple DC magnetron coating system:



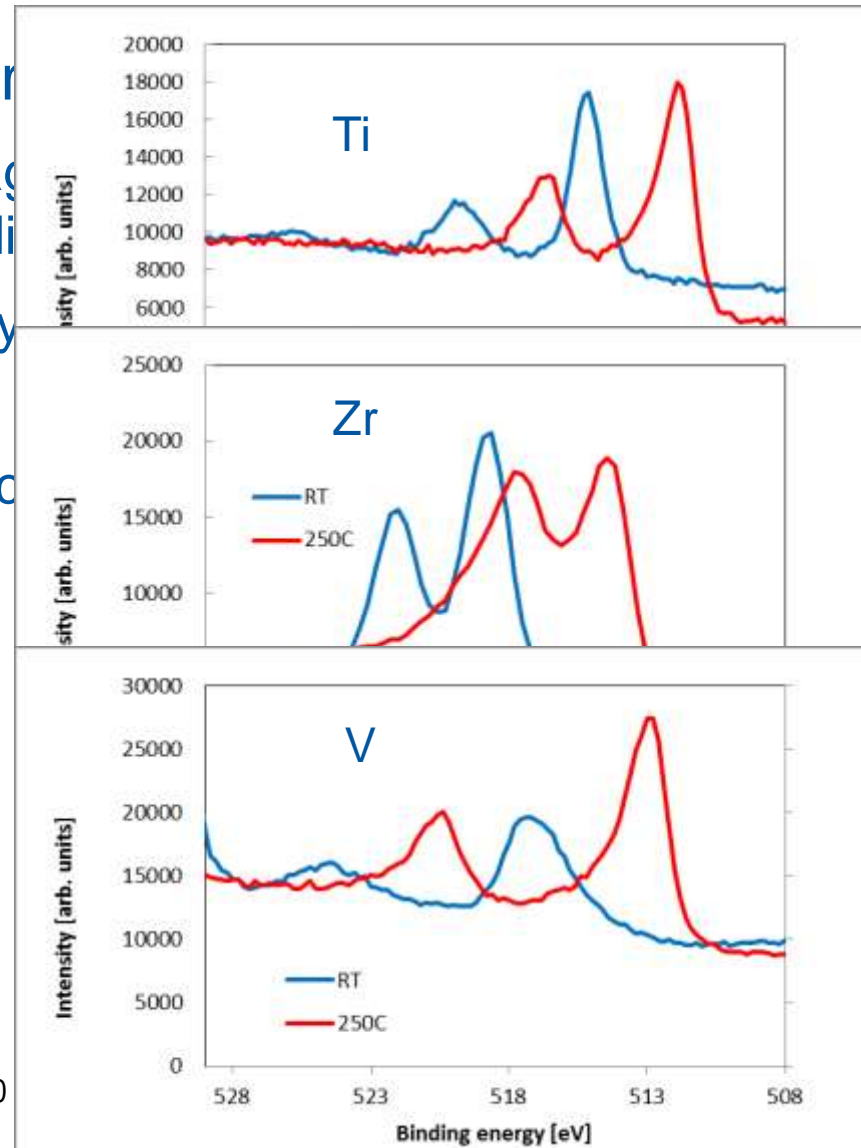
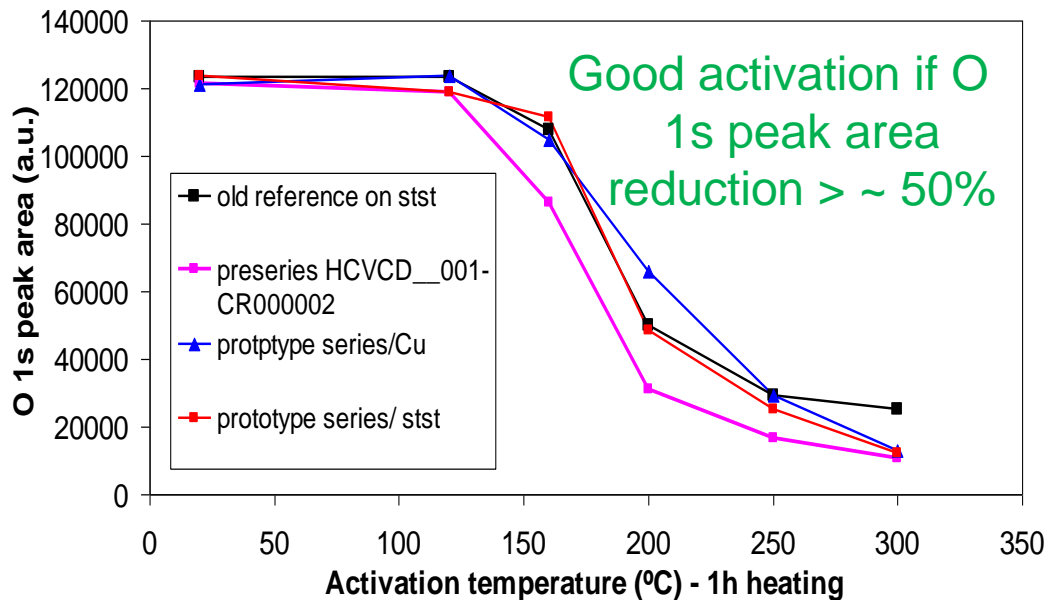
# 2 – NEG properties & performances

## NEG materials

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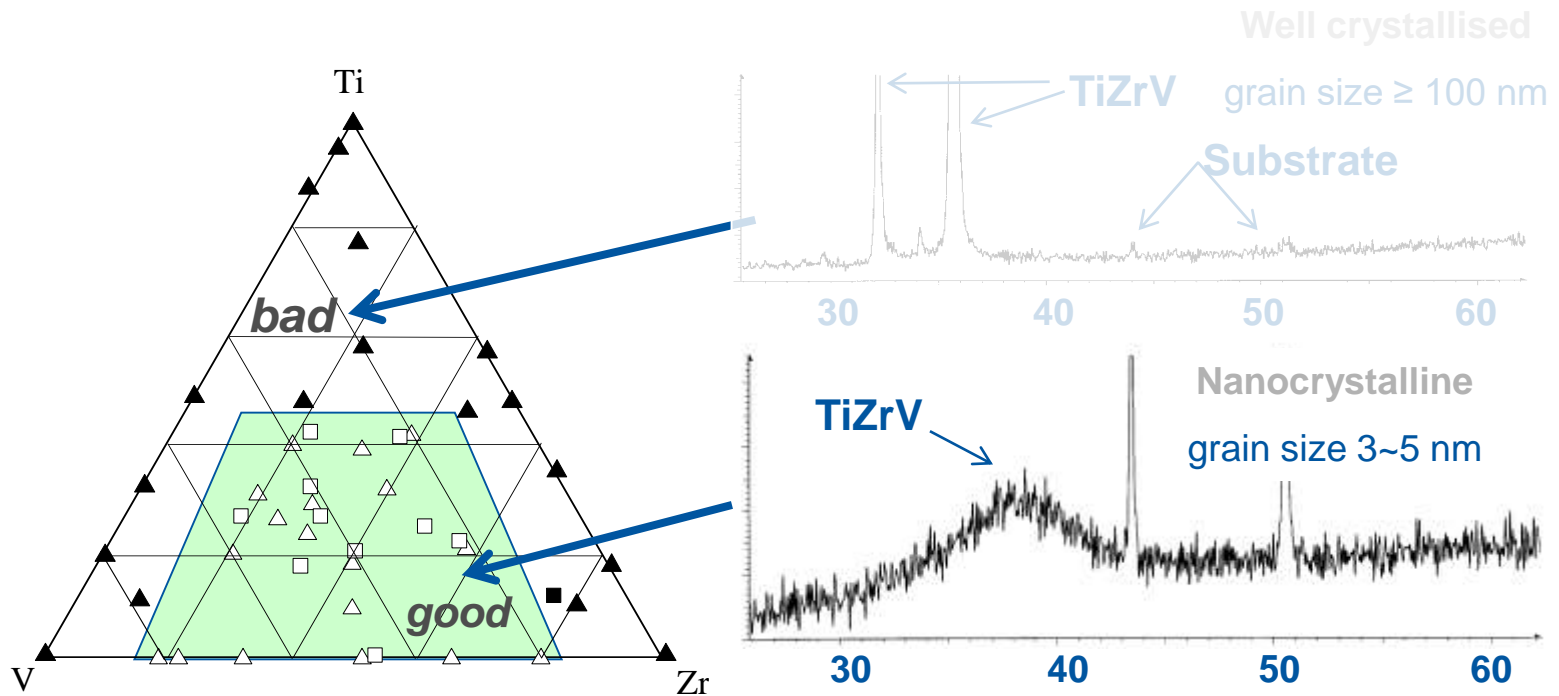
Evaluate NEG activation by X-ray Photoelectron Spectroscopy (XPS)



# 2 – NEG properties & performances

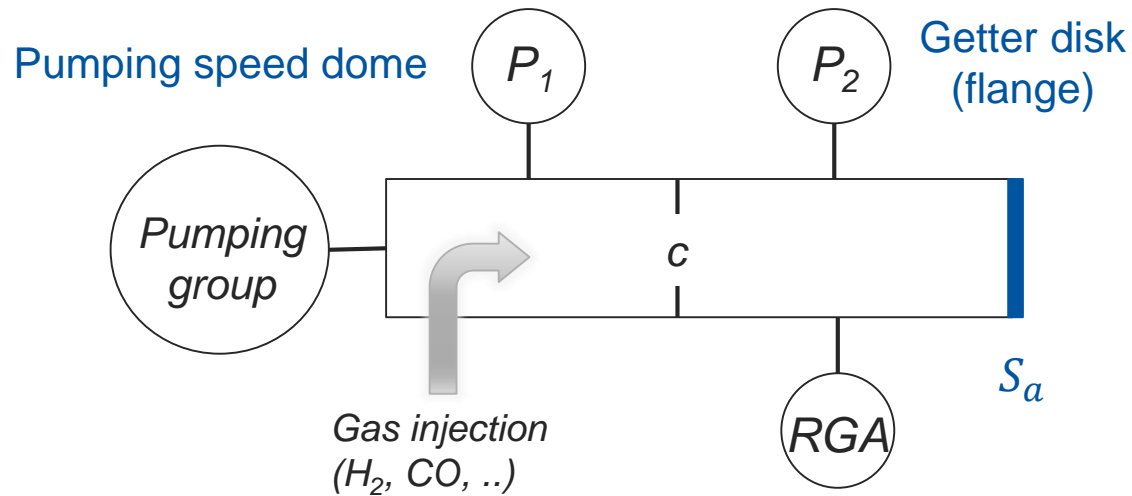
## NEG materials:

In 2002, Ti-Zr-V was retained for large scale production for the LHC.  
Activation: 24 hours at 180°C.



# 2 – NEG properties & performances

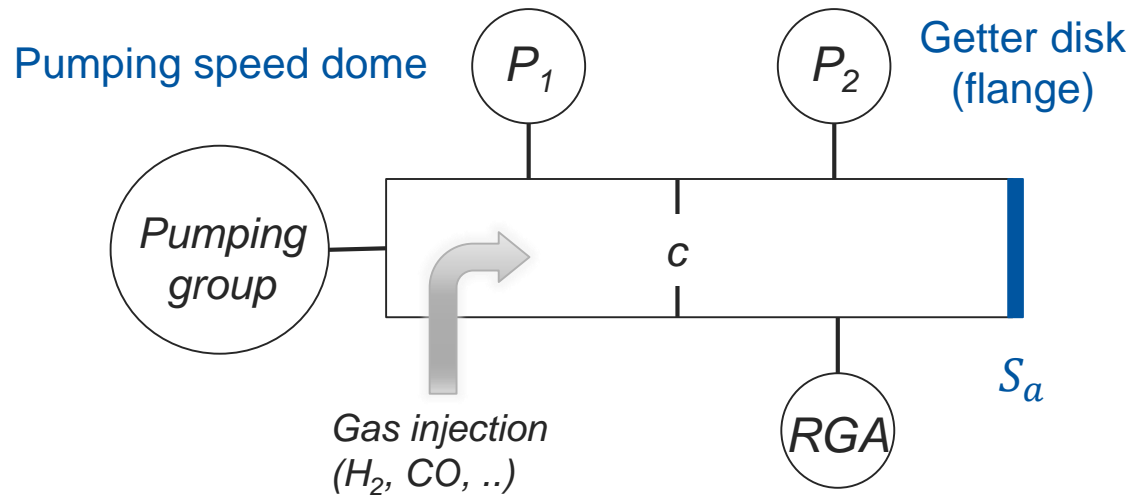
Measure the pumping speed of a thin film: aperture method



$$S_{getter} = S_a = \frac{(P_1 - P_2)}{P_2} c$$
$$S_{getter} = A \sqrt{\frac{kT}{2\pi m}} s$$
$$s = \frac{(P_1 - P_2)}{P_2} c \frac{1}{A} \sqrt{\frac{2\pi m}{kT}}$$

# 2 – NEG properties & performances

Measure the pumping speed of a thin film: aperture method



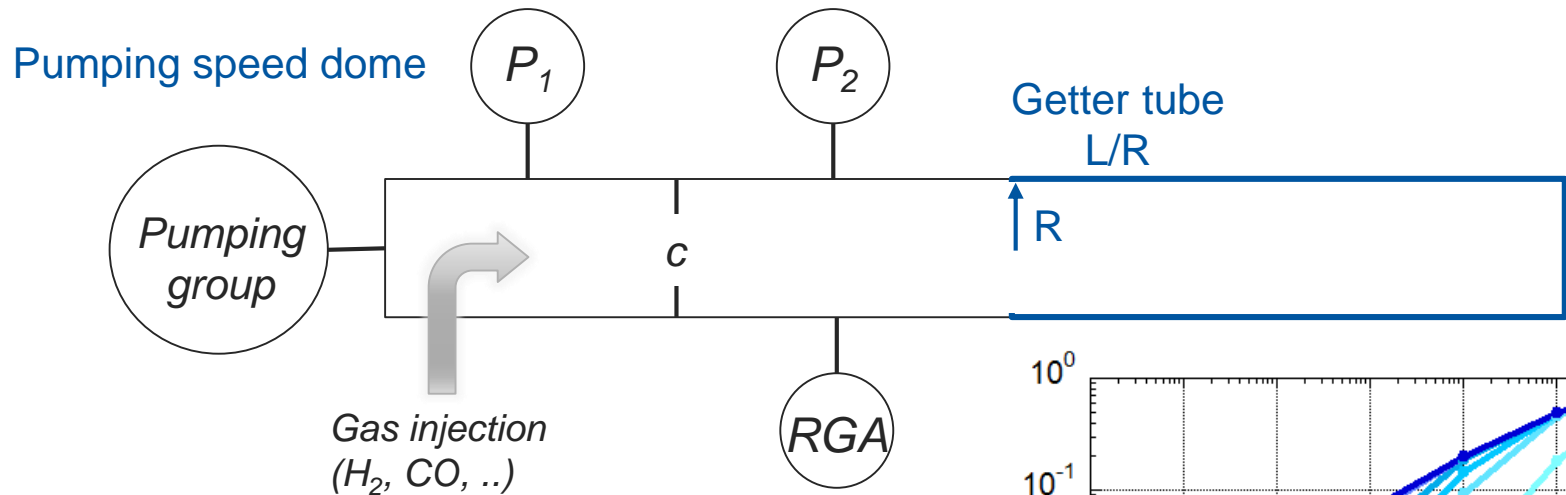
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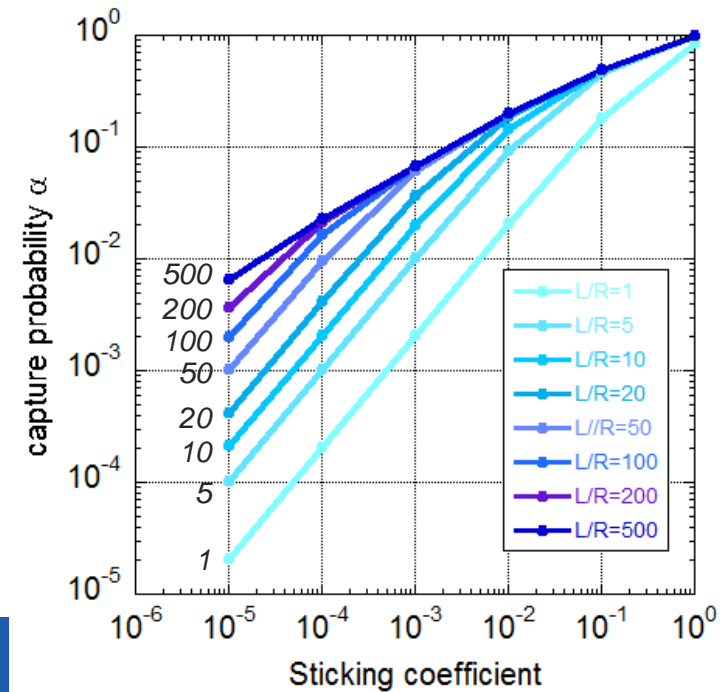


$$S_a = \frac{(P_1 - P_2)}{P_2} c$$

$$S_a = A \sqrt{\frac{kT}{2\pi m}} \alpha$$

$\alpha \rightarrow$  capture probability

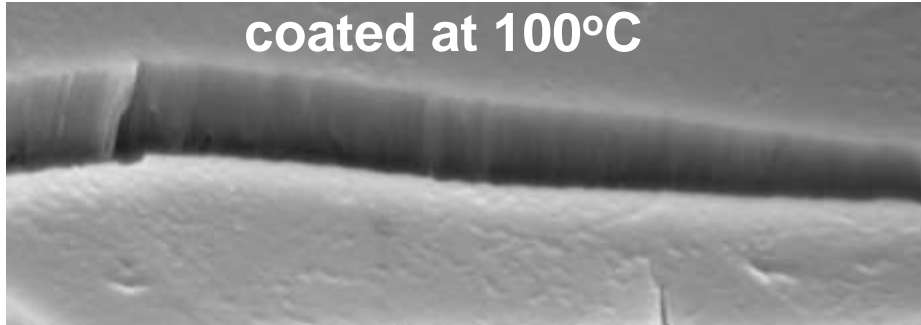
Monte Carlo simulation



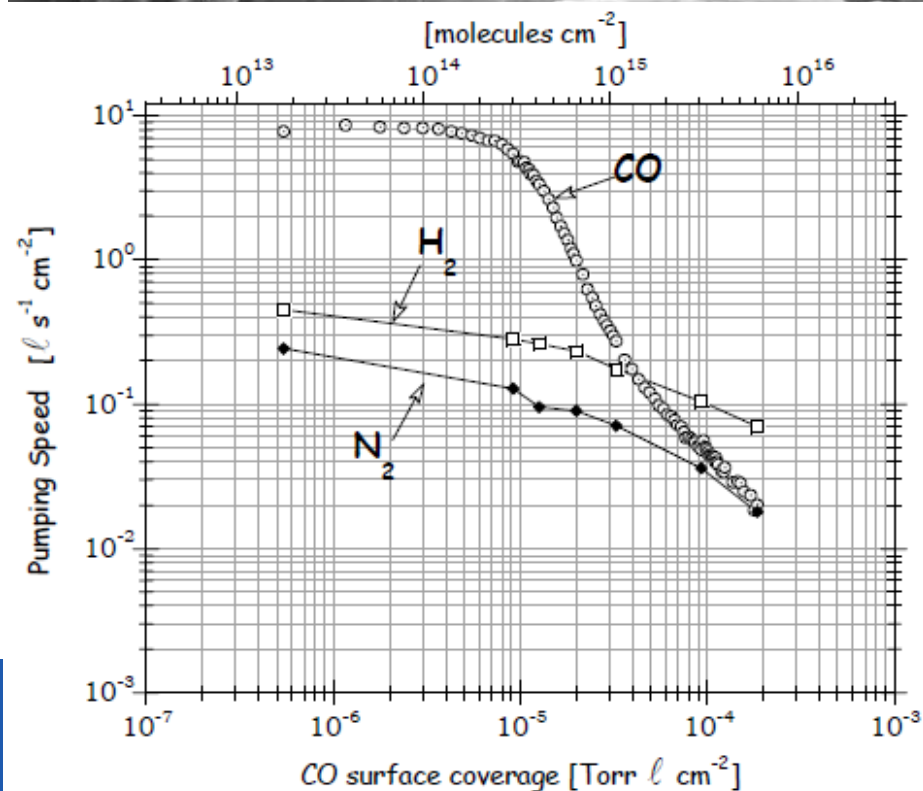
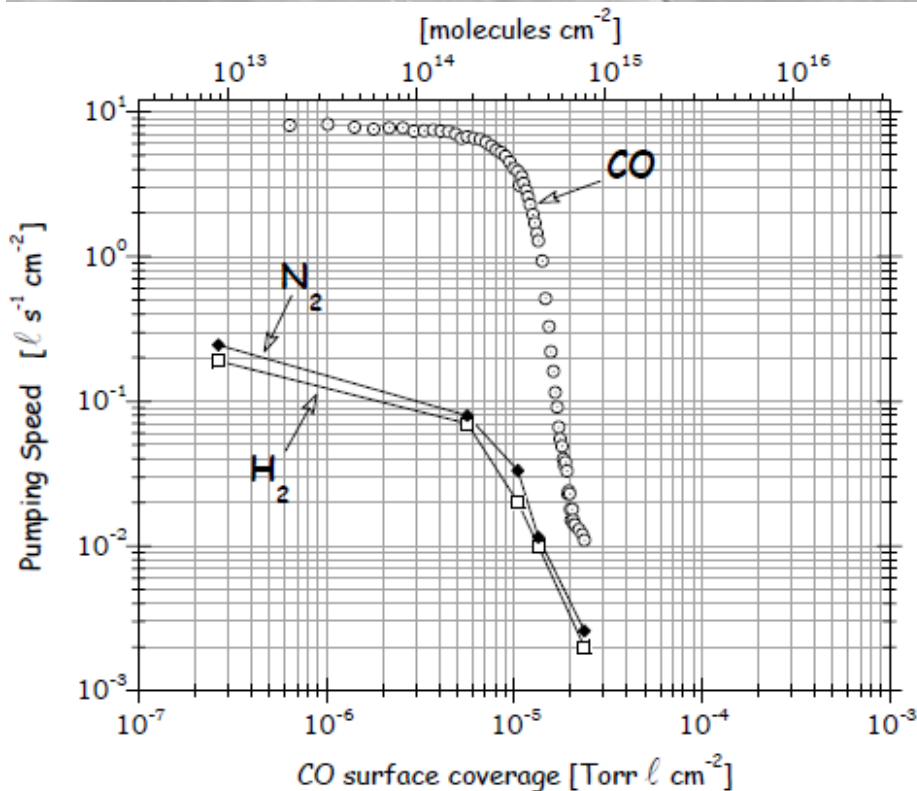
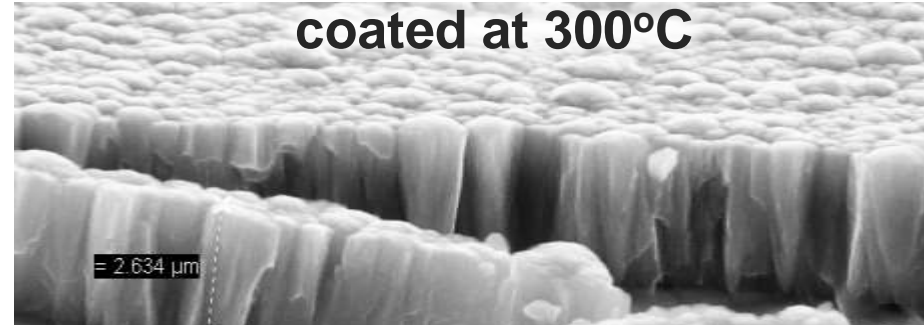
# 2 – NEG properties & performances

Pumping speed and surface capacity of TiZrV. (activation 24h@230°C)

coated at 100°C



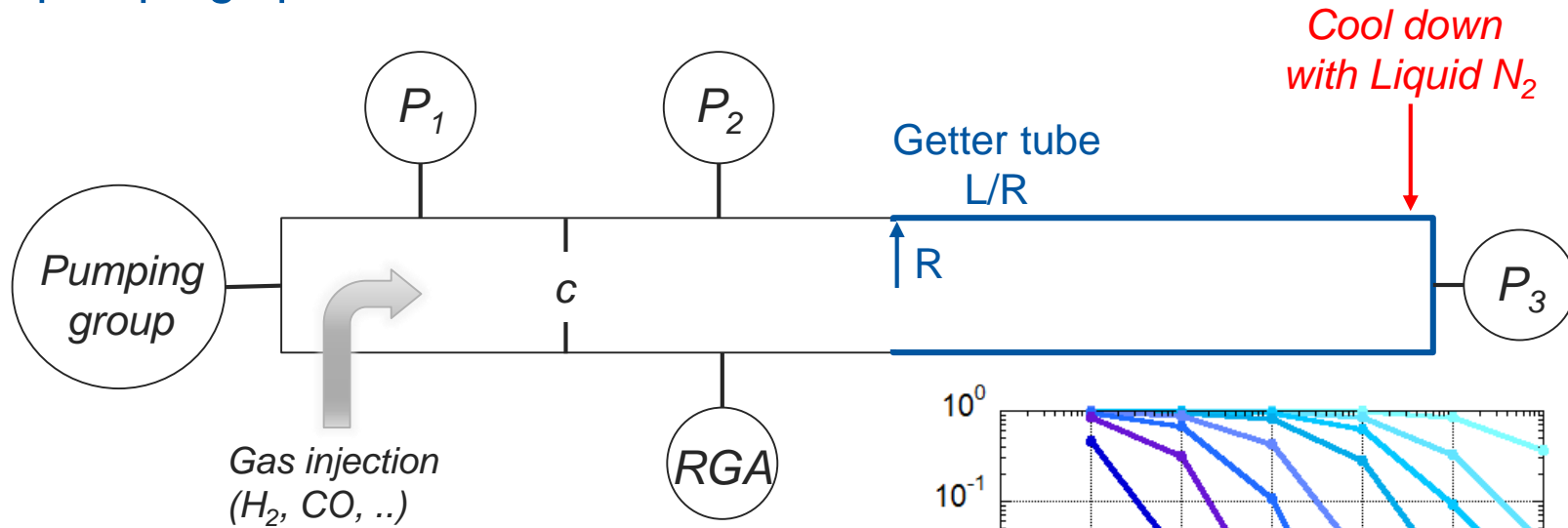
coated at 300°C





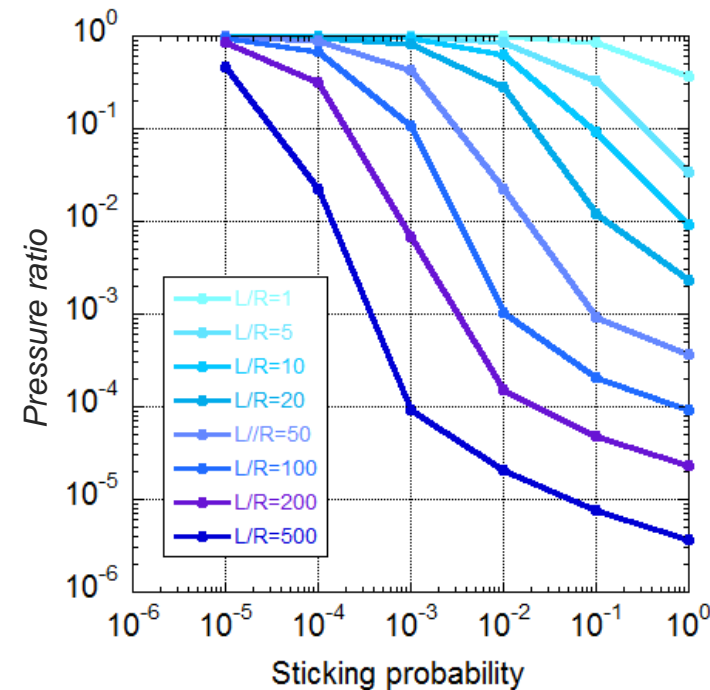
# 2 – NEG properties & performances

Measure the pumping speed of a thin film: transmission method



$$\text{Pressure ratio} = \frac{P_3}{P_2}$$

Monte Carlo simulation

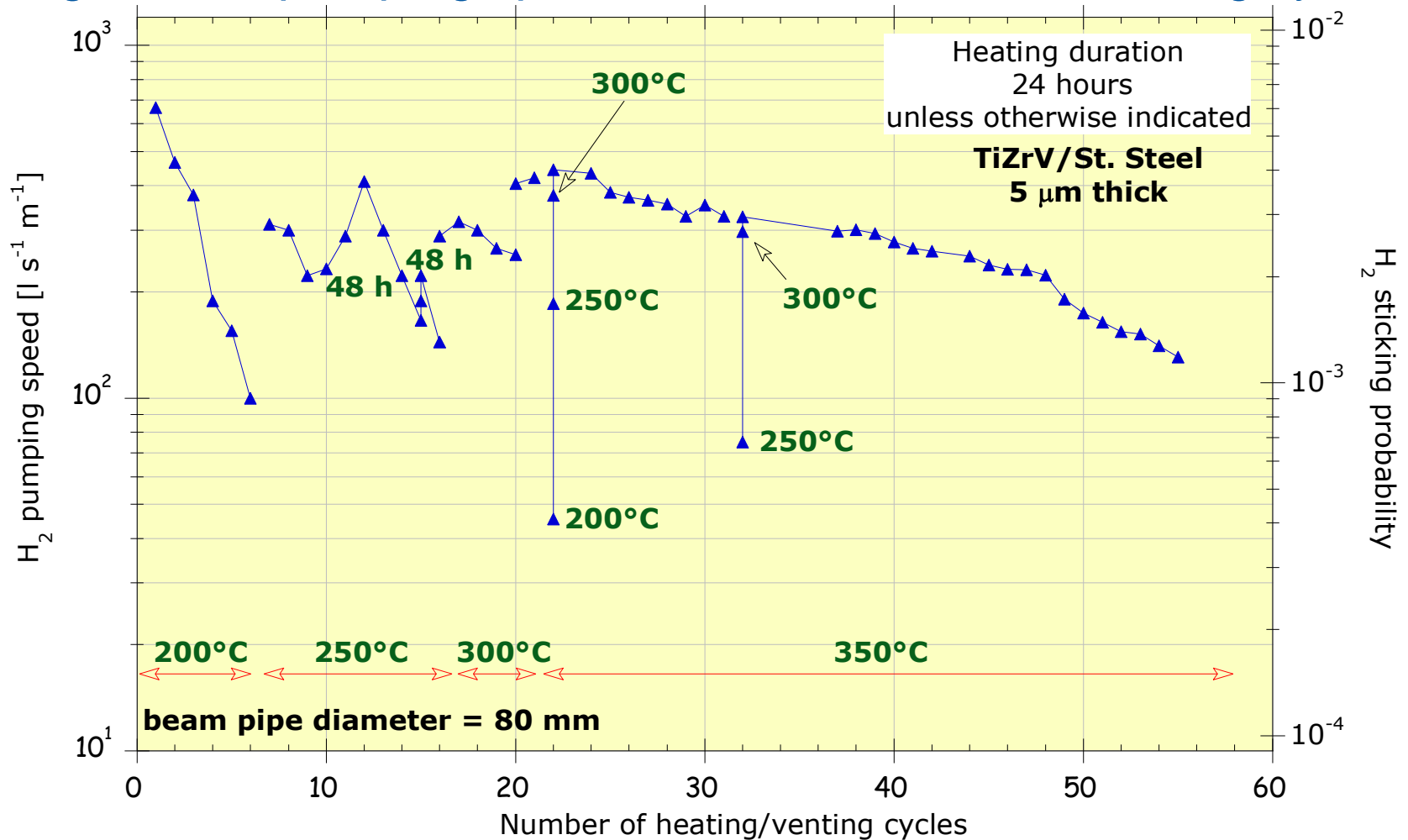


If pressure ratio too low:  
 very high  $P_2$  is necessary to get signal in  $P_3$   
 If using CO  $\Rightarrow$  fast saturation at the entrance

If using  $H_2 \Rightarrow$  dissociation of  $H_2$  in hot filament  $\Rightarrow$  methane

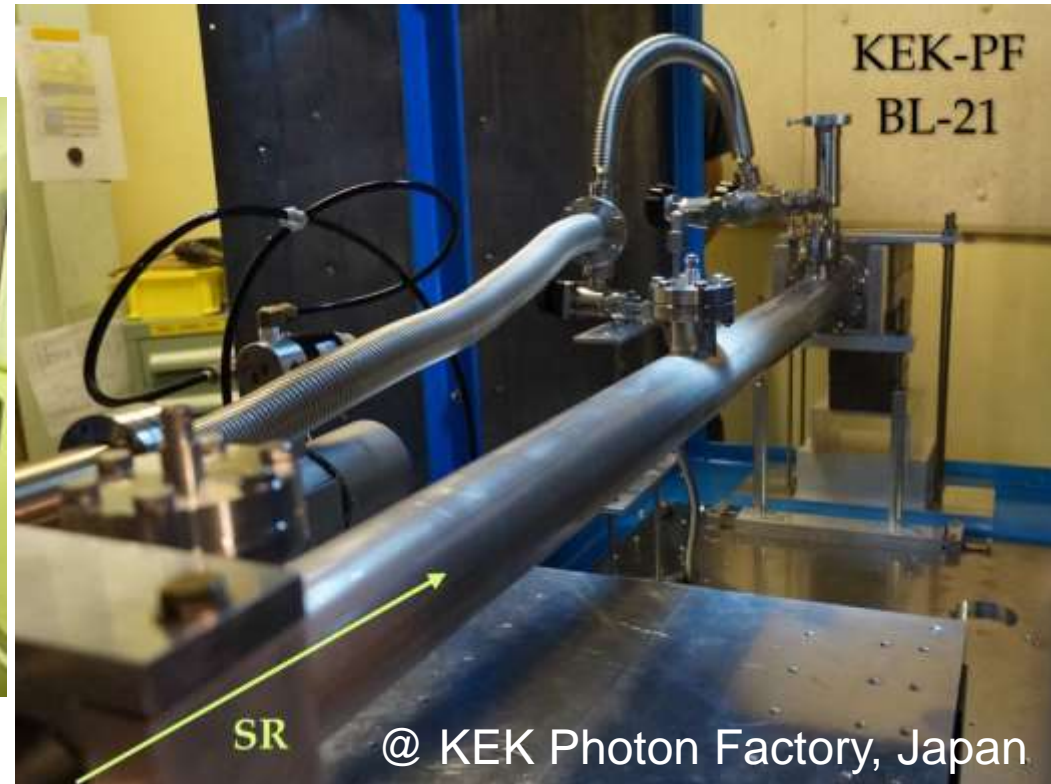
# 2 – NEG properties & performances

Ageing: loss of pumping speed with successive air venting cycles



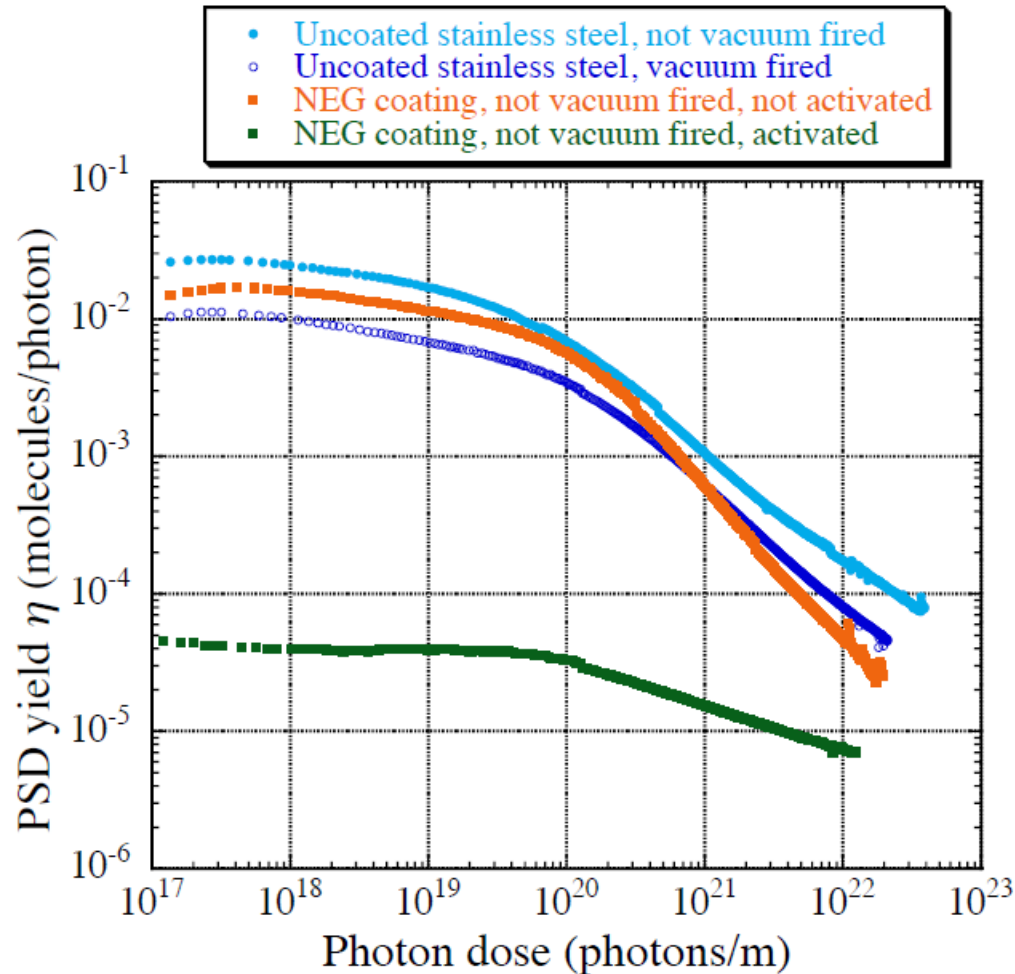
# 2 – NEG properties & performances

## Photon Stimulated Desorption (PSD)



# 2 – NEG properties & performances

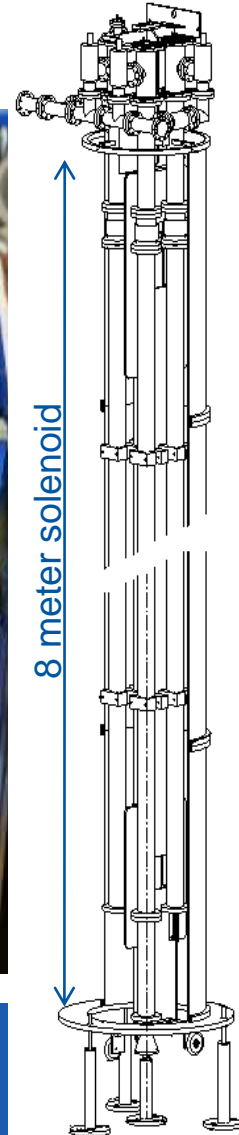
## Photon Stimulated Desorption (PSD)



# 3 – Production of NEG coatings

At CERN

The LHC: more than 1300 beam pipes coated.



# 3 – Production of NEG coatings

## NEG coating producers



# 3 – Production of NEG coatings

## Worldwide users of NEG coatings



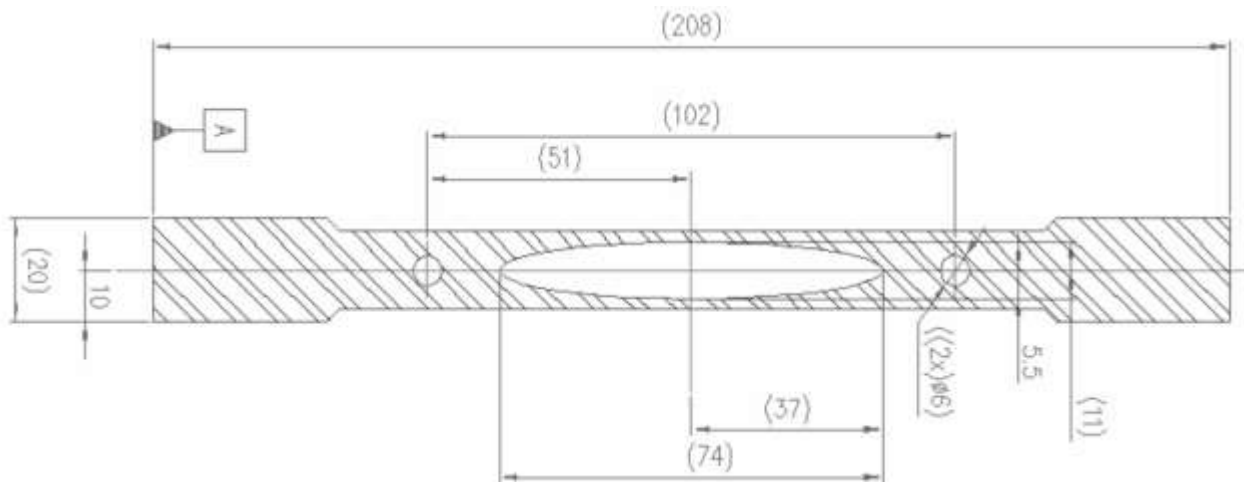
*in design/study*

# 4 – Application to synchrotrons light sources

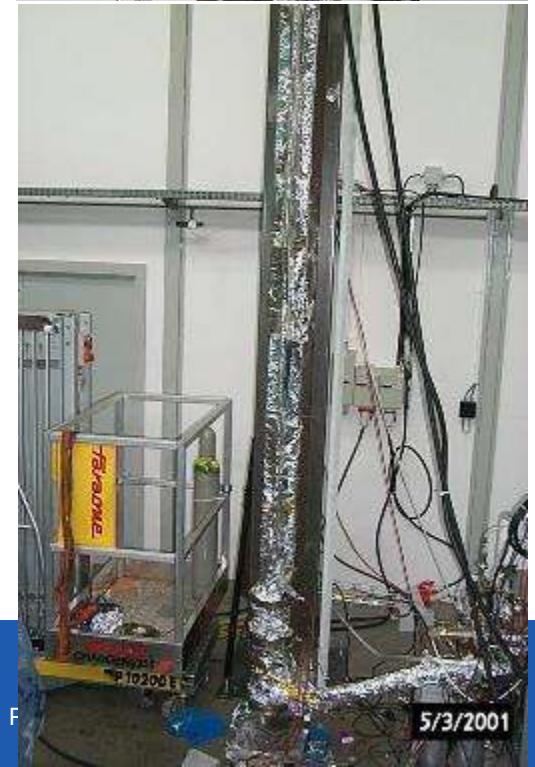
## NEG coatings for ESRF (2001)

The coating system was then dismantled: ESRF and SAES became the experts on high aspect ratio chambers. No CERN demands for these type of chambers.

ESRF chamber CV5073 (L=5073 mm, 11 mm x 74 mm)



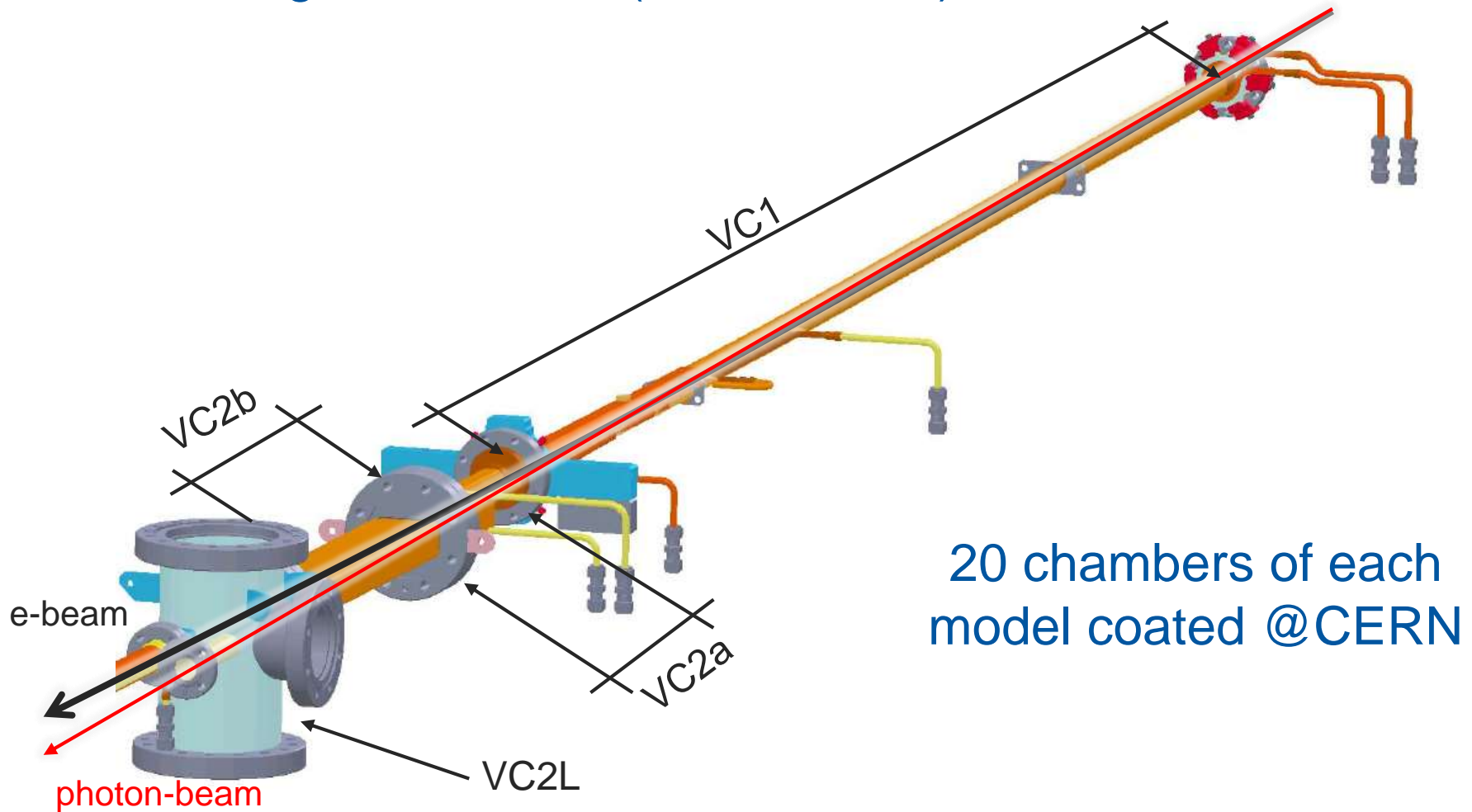
R. Kersevan, Proc. EPAC-2000 Conference, Vienna, June 2000, page 2289-2291, available at <http://accelconf.web.cern.ch/accelconf/e00/PAPERS/THP5B11.pdf>.





# 4 – Application to synchrotrons light sources

## NEG coatings for MAX IV (2013 – 2015)



# 4 – Application to synchrotrons light sources

## NEG coatings for MAX IV (2013 – 2015)



# 4 – Application to synchrotrons light sources

## Thickness uniformity

Sputtered atoms leave the target with a cosine distribution

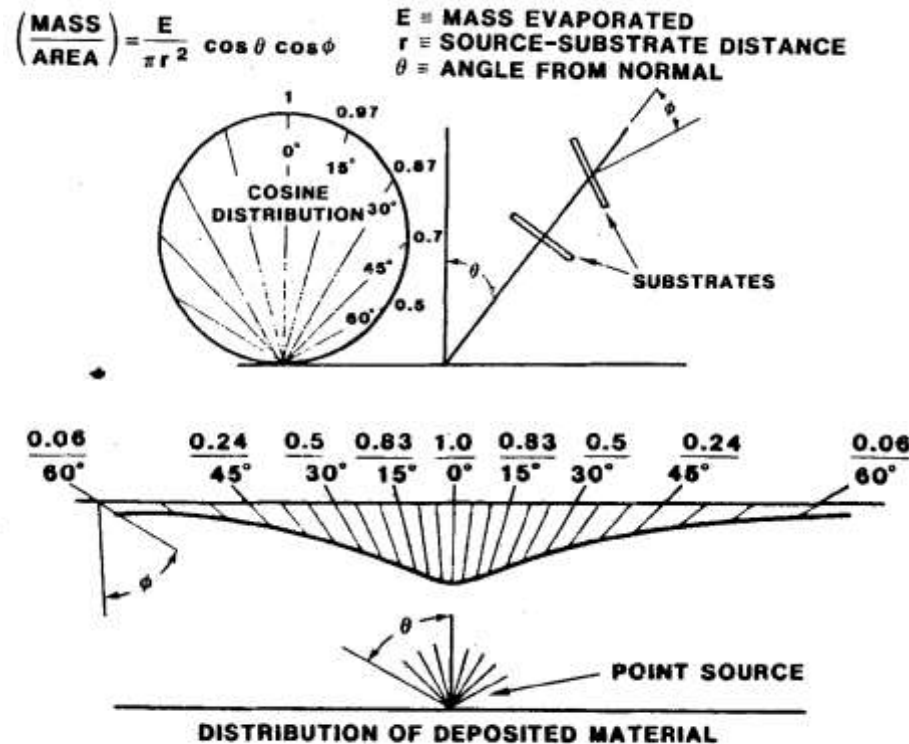


Fig. 4. Cosine distribution of vapor from a point source.

# 4 – Application to synchrotrons light sources

## Thickness uniformity

Cross section:

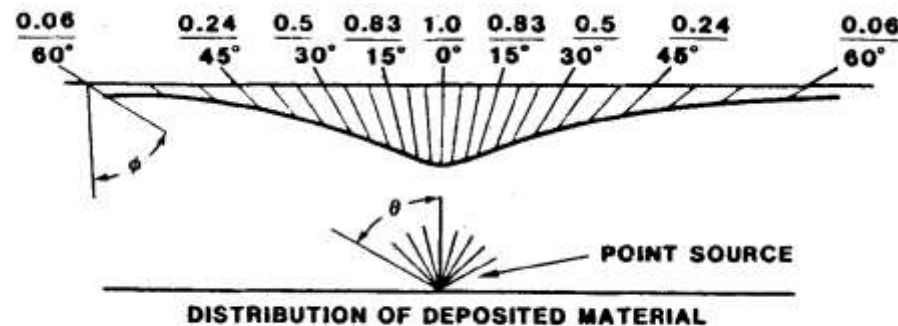
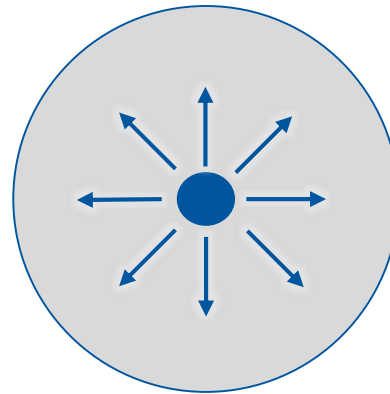
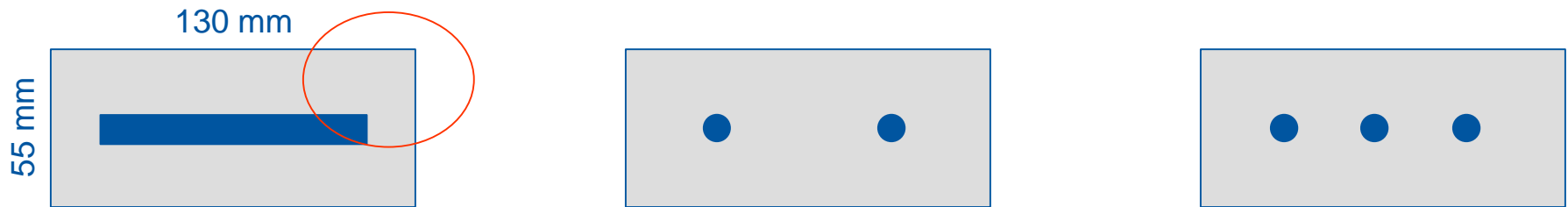


Fig. 4. Cosine distribution of vapor from a point source.

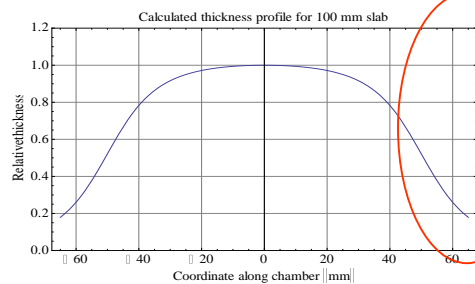
# 4 – Application to synchrotrons light sources

## Thickness uniformity

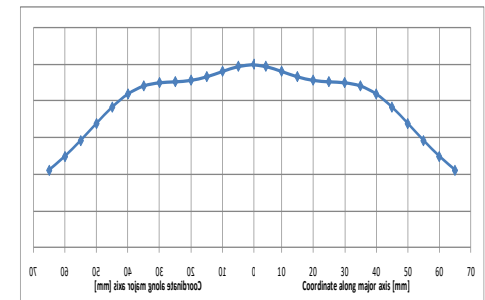
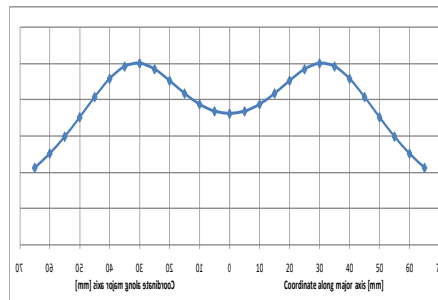
Cross section:



Which cathode gives the most uniform thickness profile?



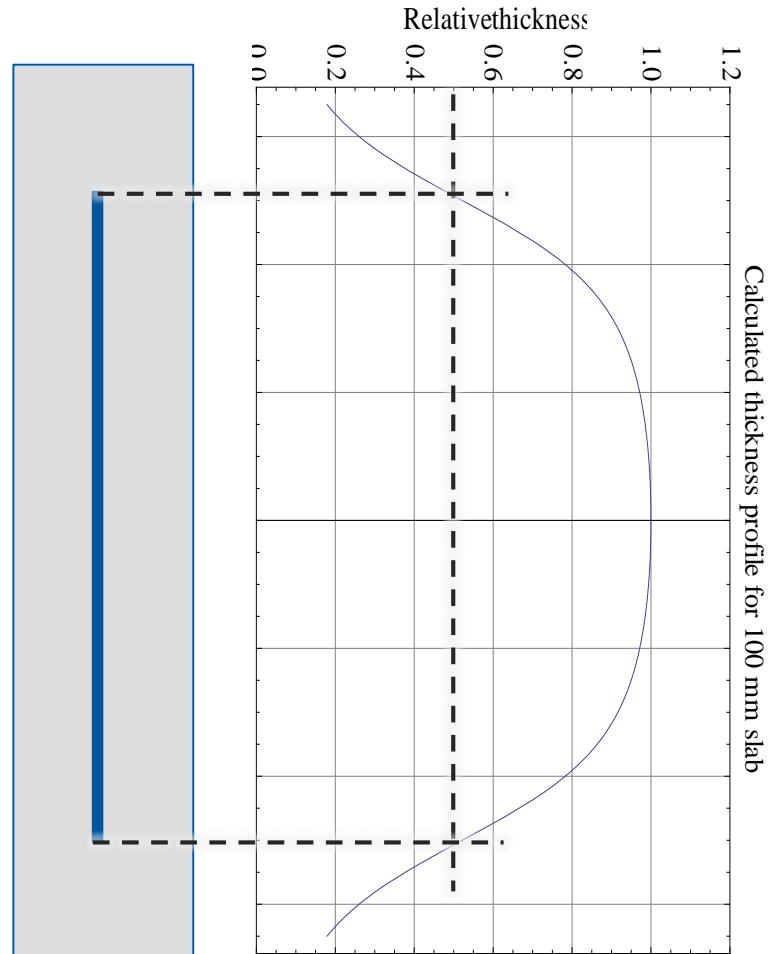
Edge effect



# 4 – Application to synchrotrons light sources

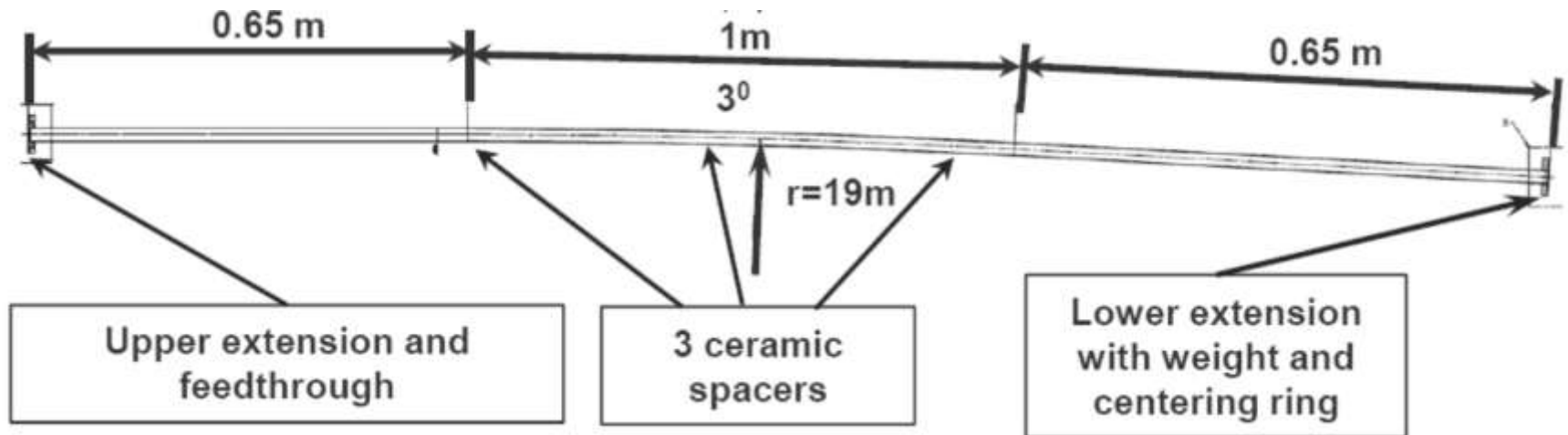
## Thickness uniformity

Longitudinal:



# 4 – Application to synchrotrons light sources

## NEG coatings for MAX IV (2013 – 2015)

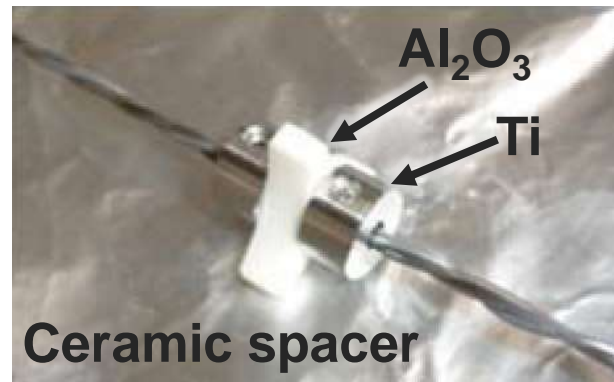


### Chamber:

- ID22 mm
- L=2.3 m
- Angle 3°
- curvature radius 19 m

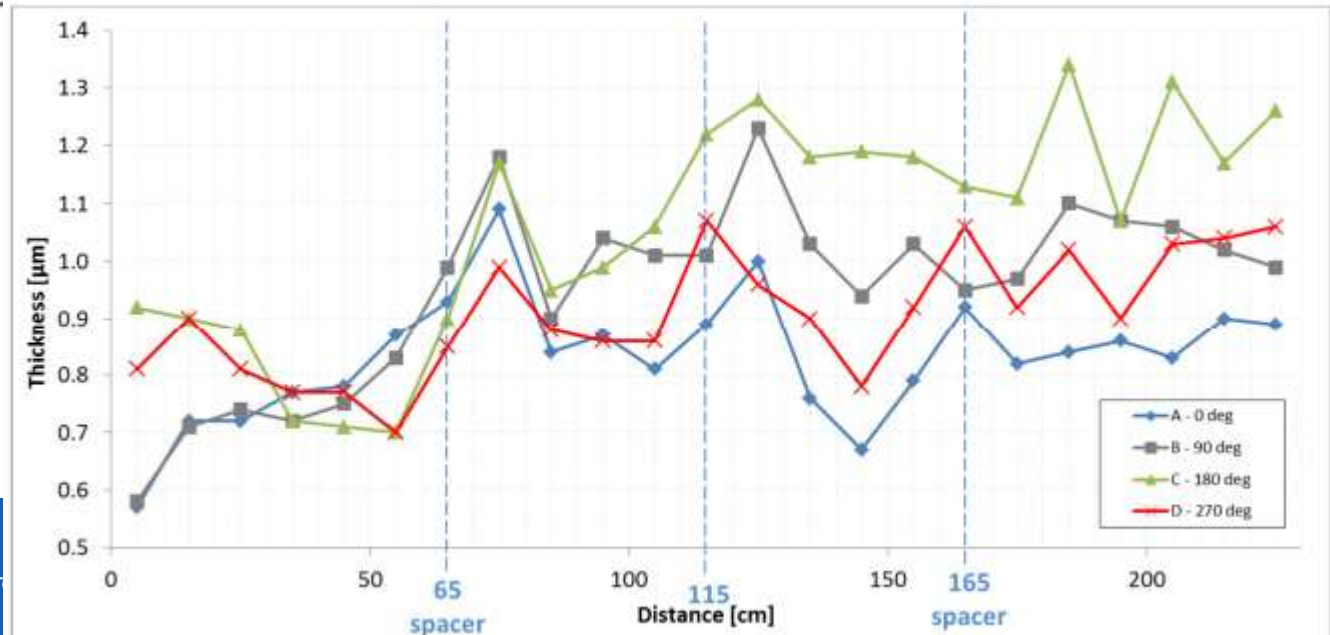
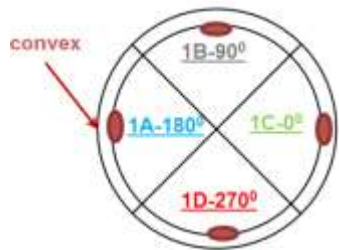
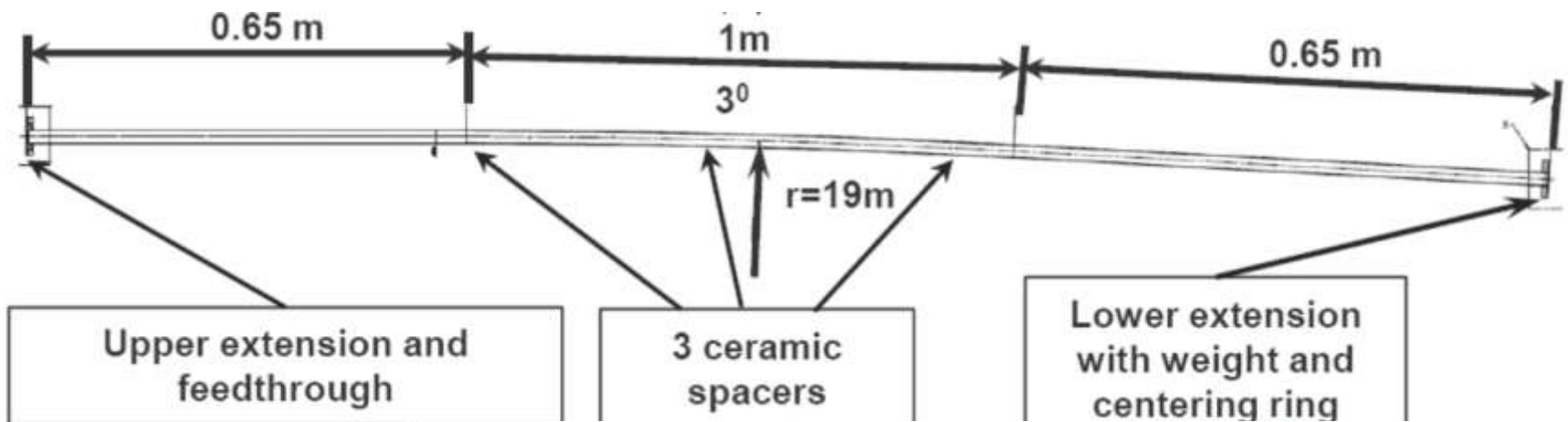
### Coating:

- Pressure 0.11 mbar
- Magnetic field 180 Gauss
- Power density 25W/m



# 4 – Application to synchrotrons light sources

## NEG coatings for MAX IV (2013 – 2015)

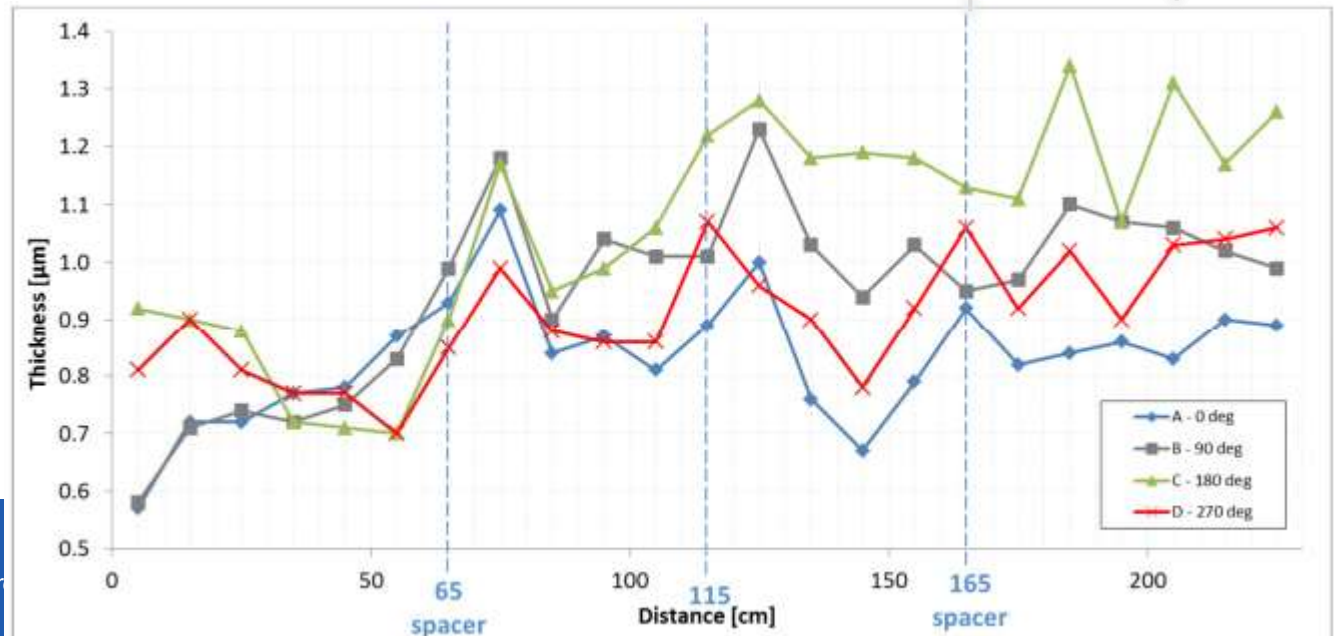
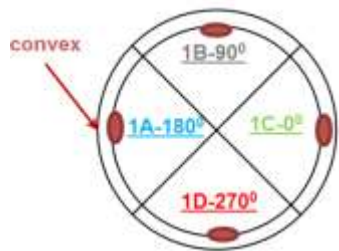
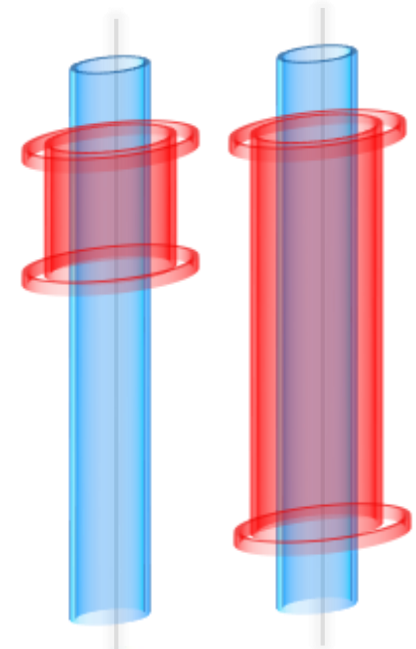




# 4 – Application to synchrotrons light sources

NEG coatings for MAX IV (2013 – 2015)

Use “short” solenoids? (plasma distribution)



# 4 – Application to synchrotrons light sources

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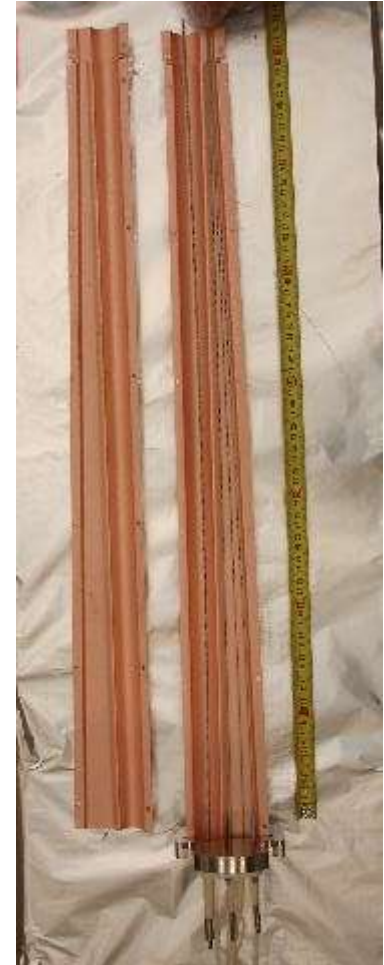
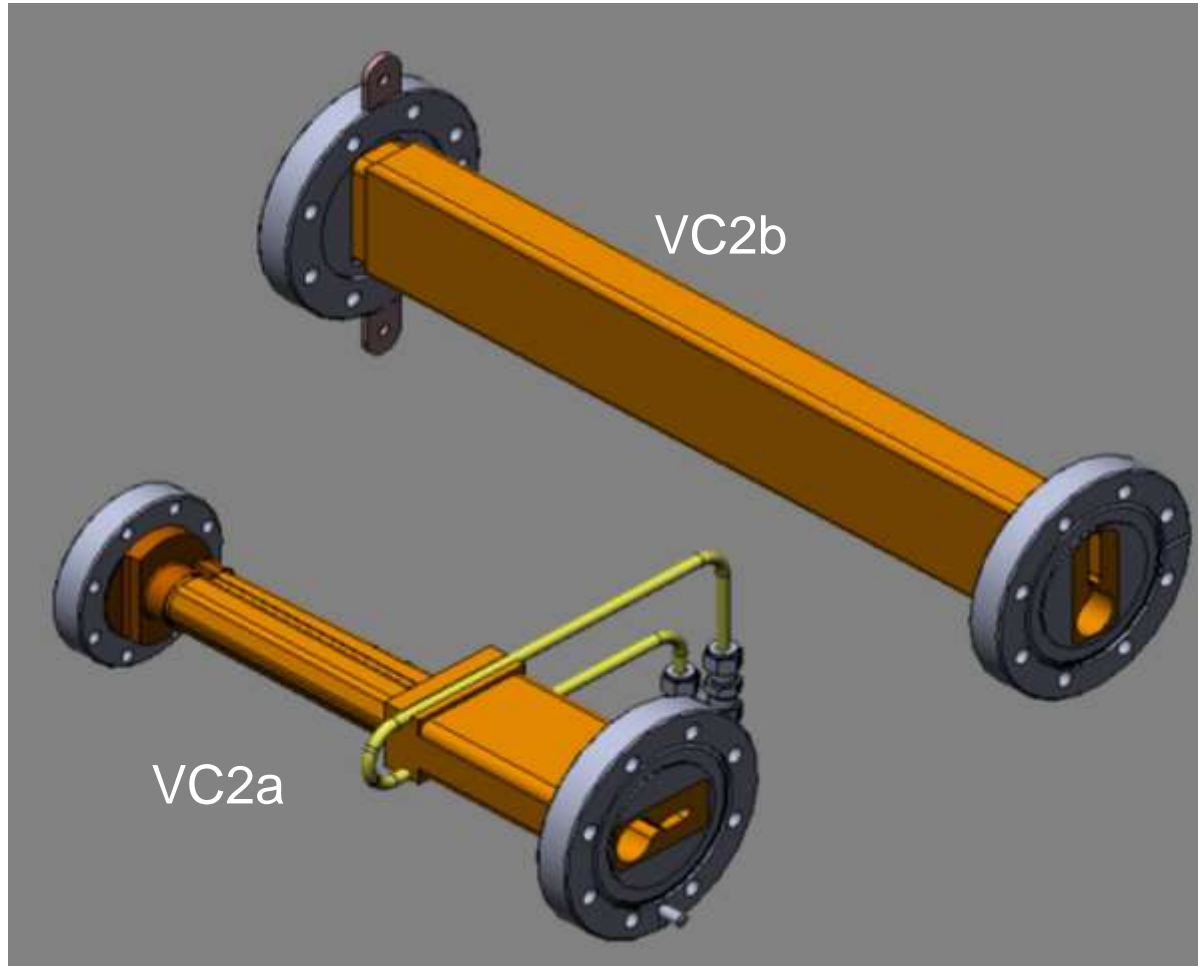
# 4 – Application to synchrotrons light sources

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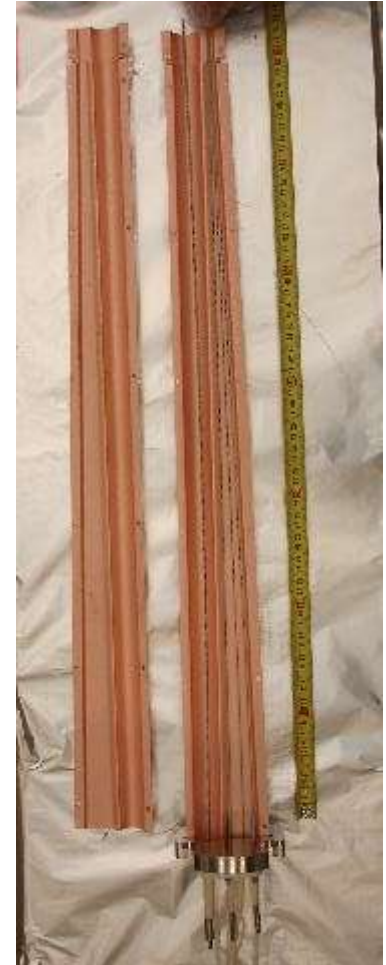
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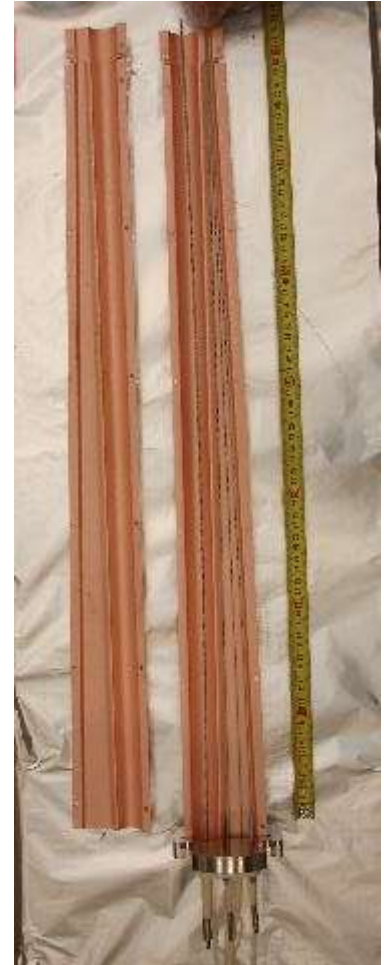
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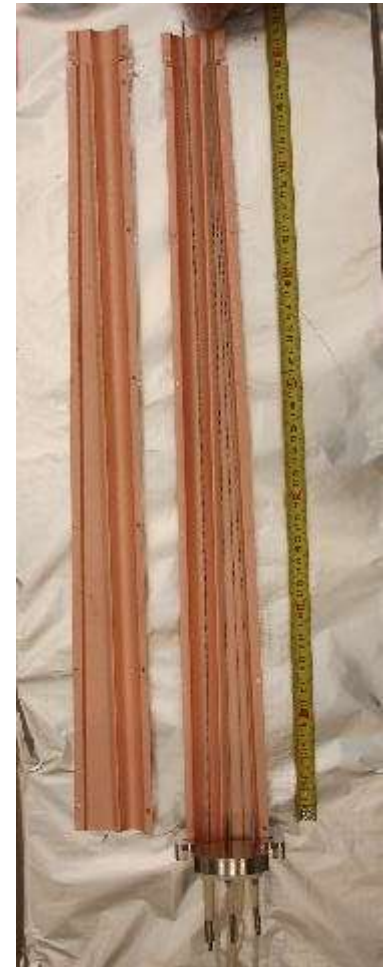
# 4 – Application to synchrotrons light sources

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# 4 – Application to synchrotrons light sources

## NEG coatings for MAX IV (2013 – 2015)

1<sup>st</sup> problem:

“spread” the plasma  
along the cathode



Requires high  
power



# 4 – Application to synchrotrons light sources

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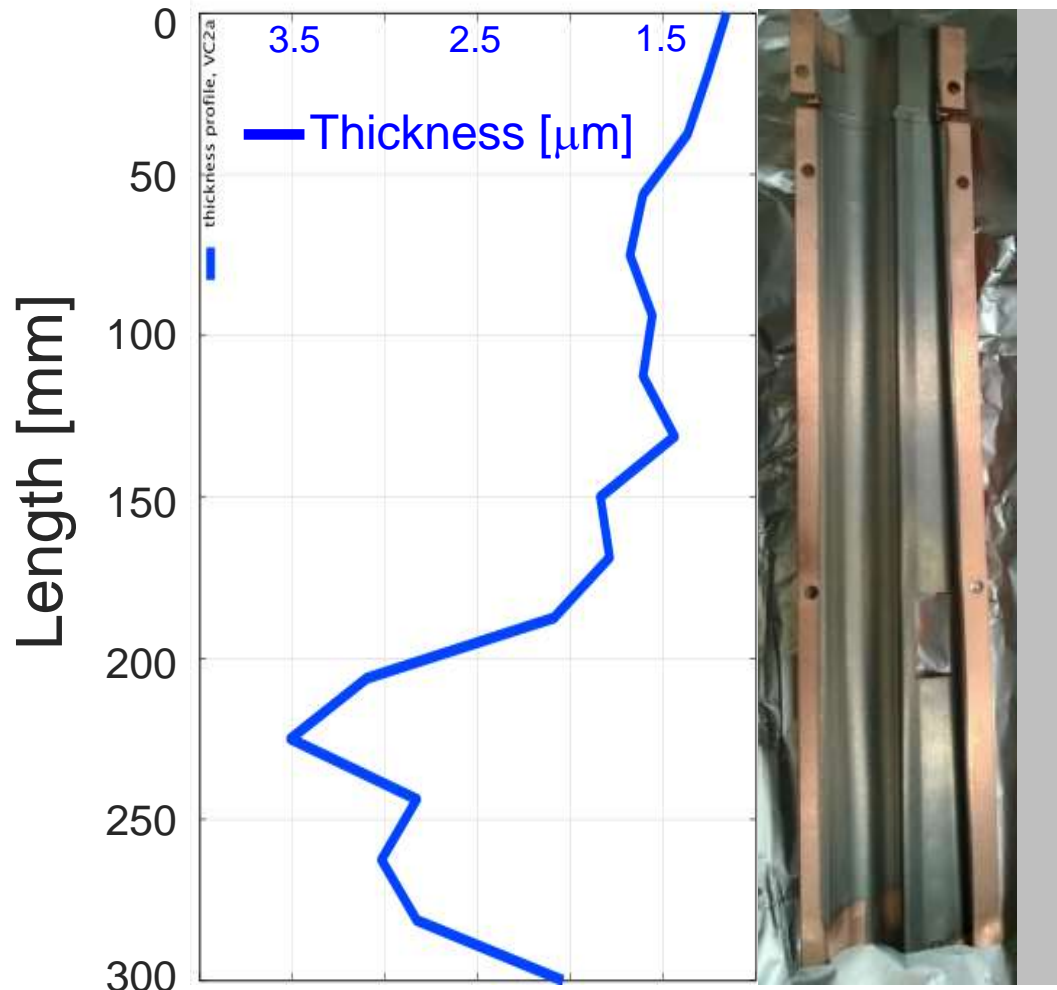
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wrong  
stoichiometry  
(too much V)



Incomplete activation



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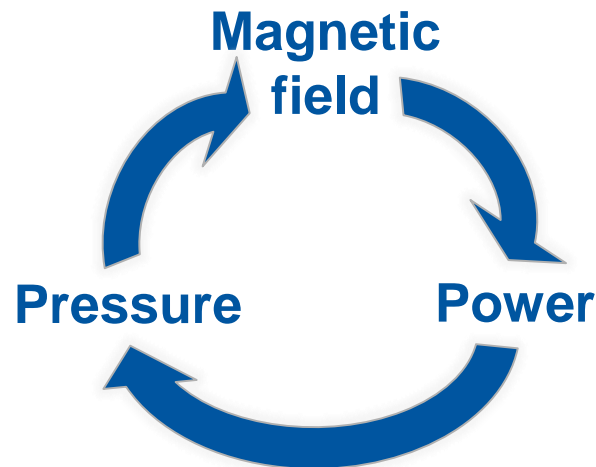
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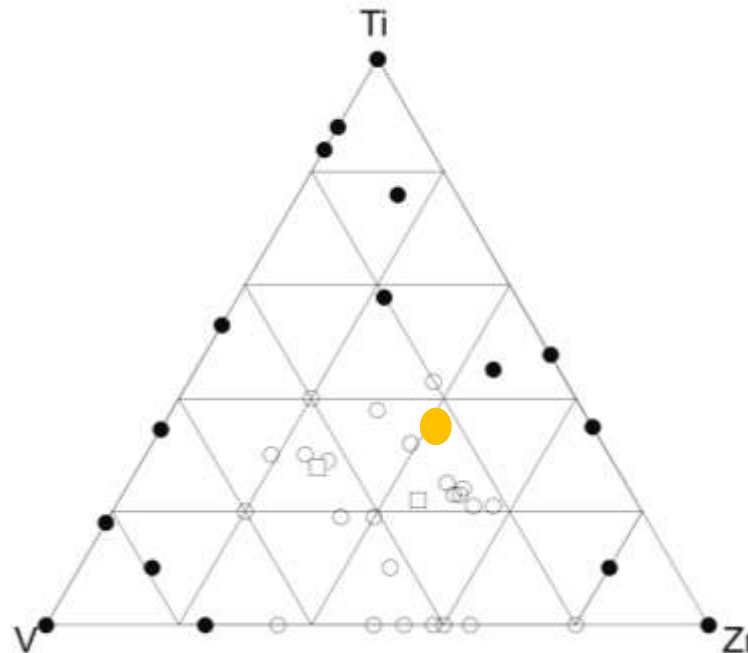
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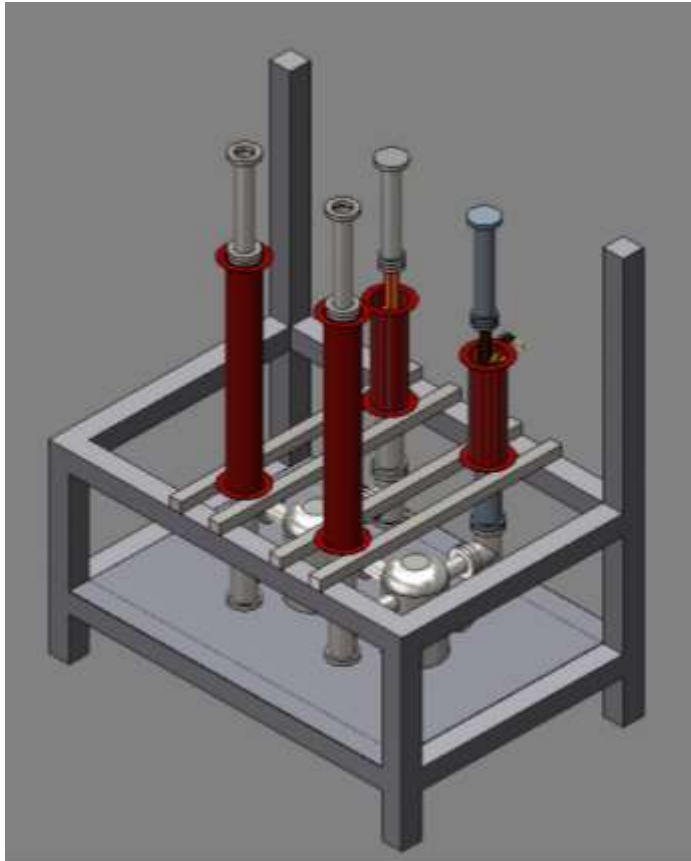


Incomplete activation



# 4 – Application to synchrotrons light sources

## NEG coatings for MAX IV (2013 – 2015)



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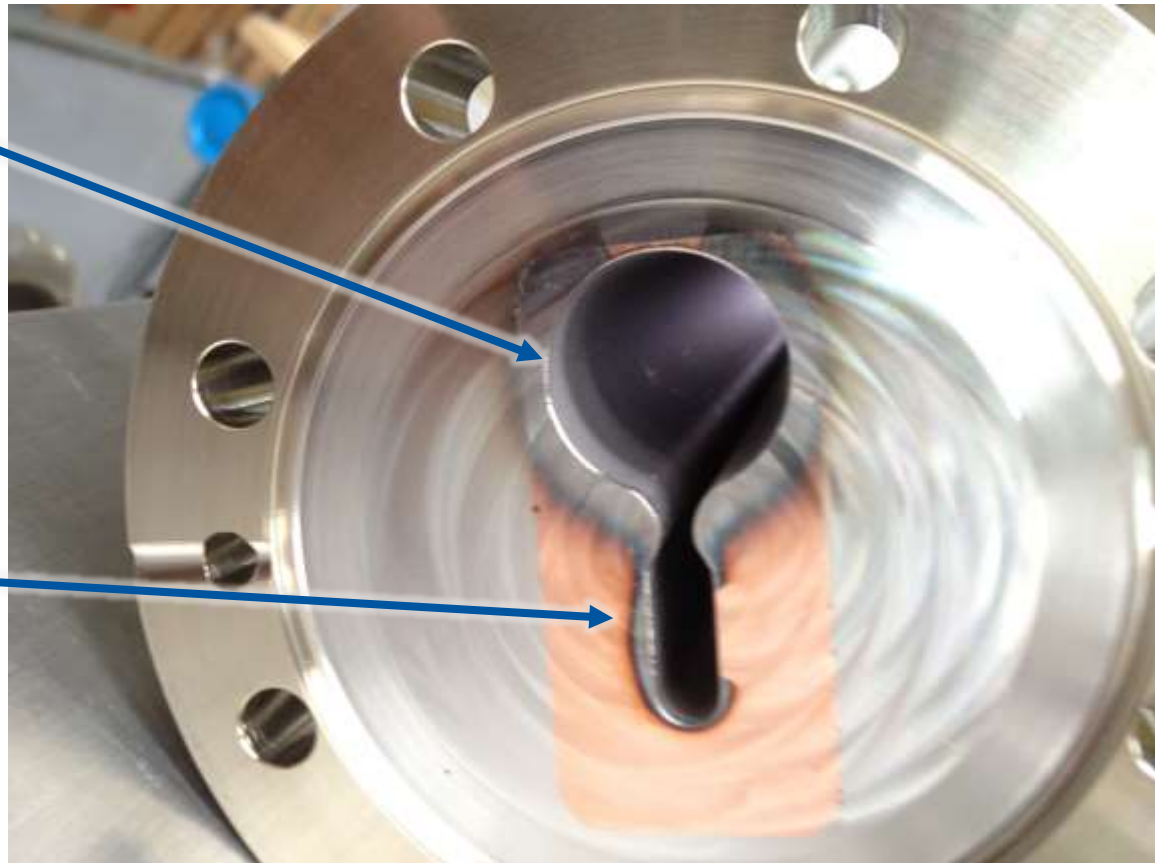
## NEG coatings for MAX IV (2013 – 2015)

### Electron chambers:

- ID22 mm
- L=300 (435) mm
- Pressure 0.06 mbar
- Magnetic field 180 Gauss
- Power Density 25 W/m

### Photon chambers:

- From 6x11 mm to 7x34 mm
- L=300 (435) mm
- Pressure 0.66 mbar
- Magnetic field 500 Gauss
- Power Density 25 W/m



# 4 – Application to synchrotrons light sources

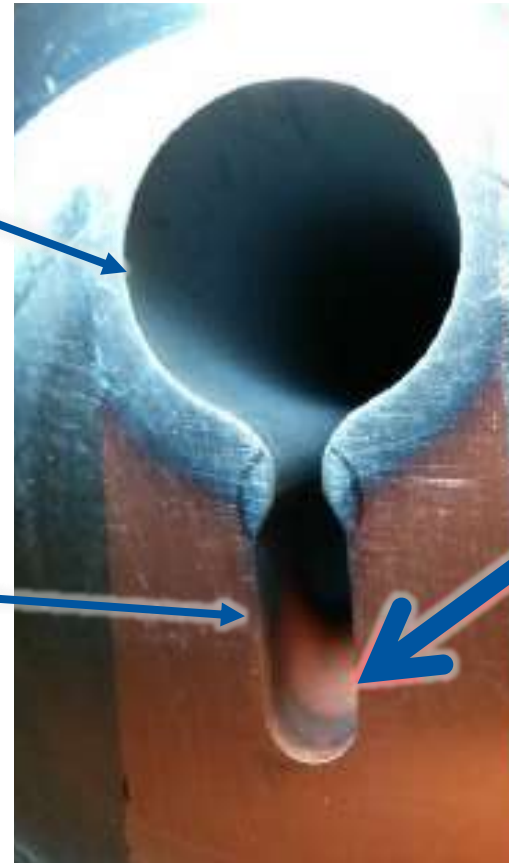
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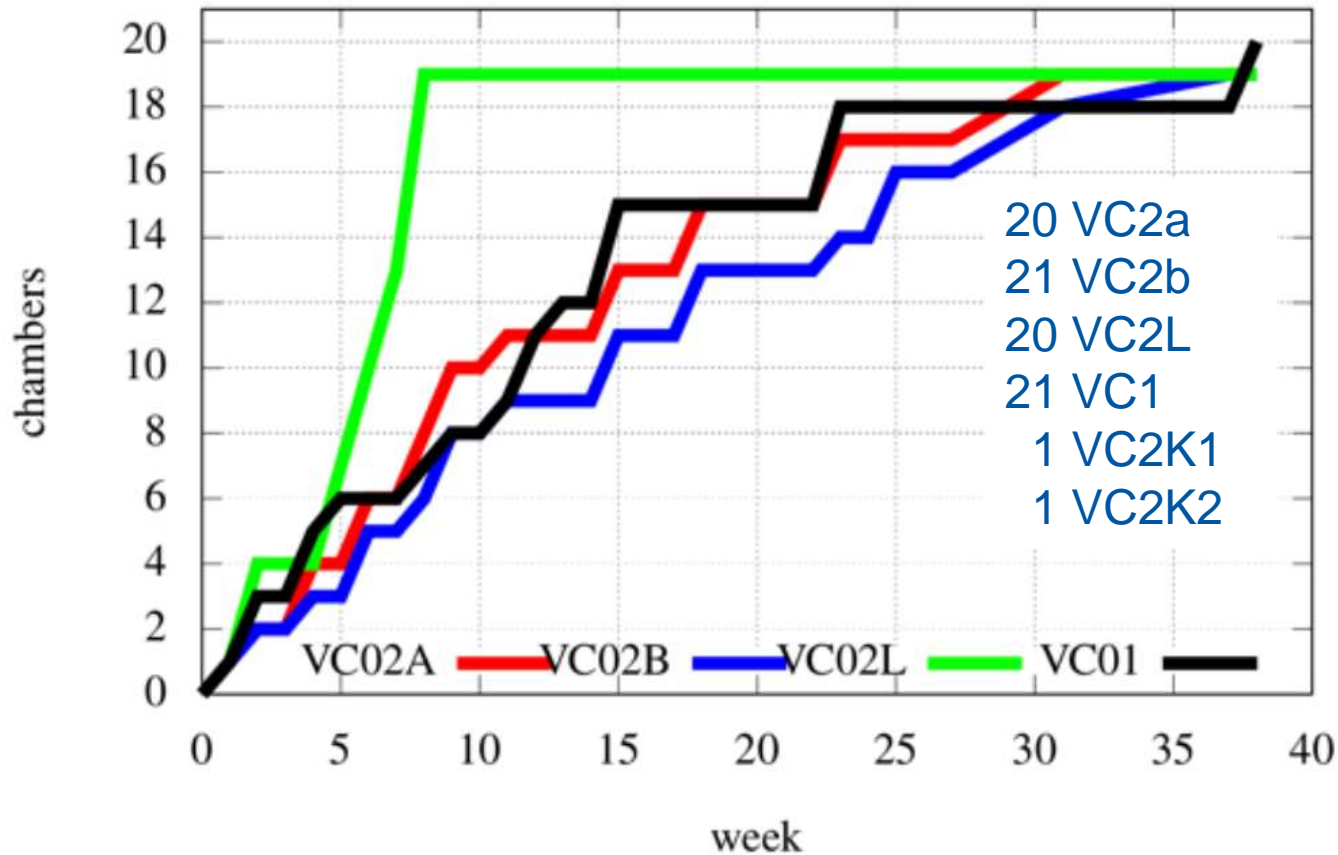
few chambers  
with  $\sim 3 \text{ cm}^2$   
uncoated area on  
the smaller gap



# 4 – Application to synchrotrons light sources

## NEG coatings for MAX IV (2013 – 2015)

Between July 2014 and April 2015



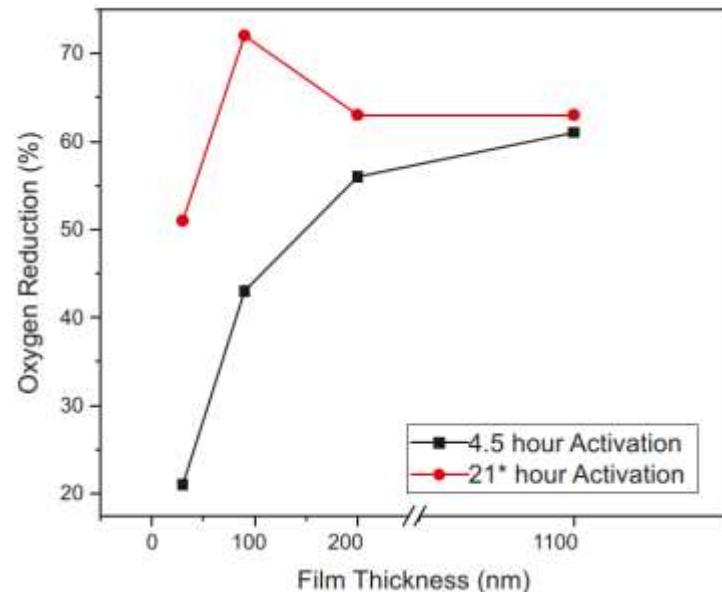
# 4 – Application to synchrotrons light sources

What is the required thickness? => minimize beam impedance

Coat films with different thicknesses: 30 nm, 90 nm, 200 nm, 1100 nm.

(Motivation: minimize impedance for the Future Circular Collider)

Reduction of oxygen after 4 venting/activation cycles



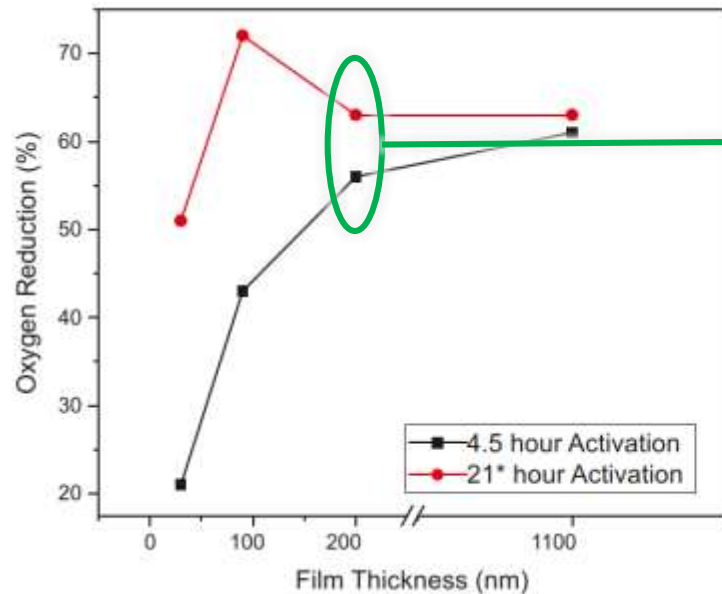
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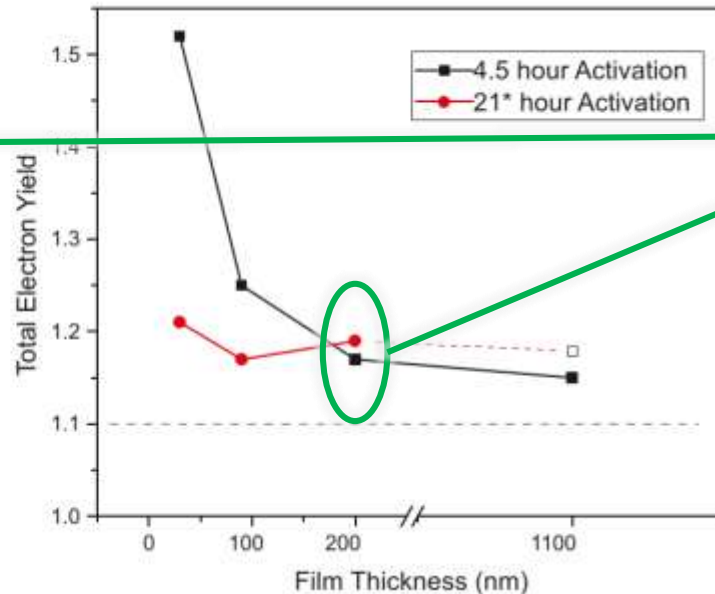
Coat films with different thicknesses: 30 nm, 90 nm, 200 nm, 1100 nm.

(Motivation: minimize impedance for the Future Circular Collider)

Reduction of oxygen after 4 venting/activation cycles



Secondary electron yield after 4 venting/activation cycles

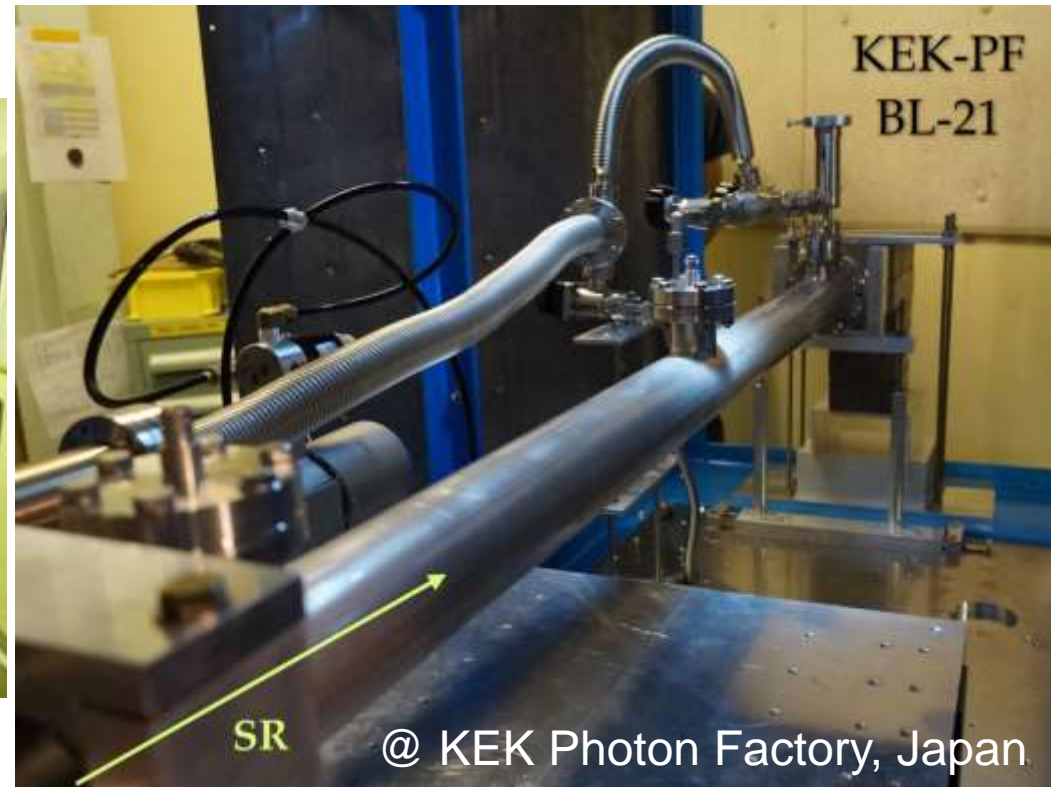


**200 nm is enough**  
4x venting/activation cycles

# 4 – Application to synchrotrons light sources

What is the required thickness? => minimize beam impedance

What is the evolution of the PSD from a 200 nm film in function of venting/activation cycles?



# 4 – Application to synchrotrons light sources

What is the required thickness? => minimize beam impedance

What is the evolution of the PSD from a 200 nm film in function of venting/activation cycles?

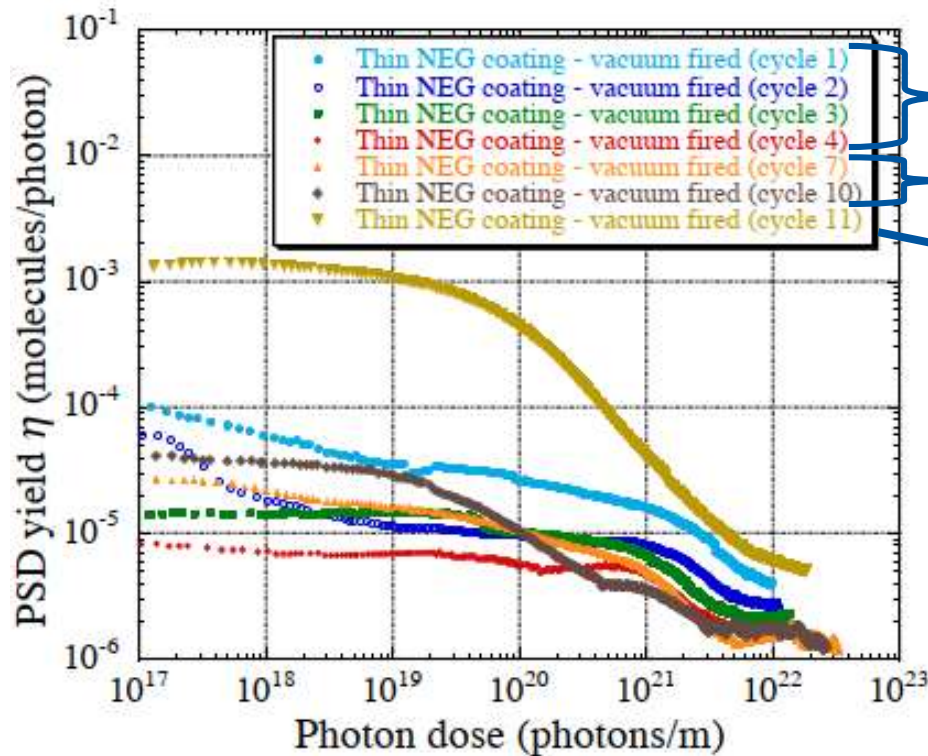
	1	2	3	4	5	6	7	8	9	10	11	
1. Vent with dry air, then expose to atmosphere		<30 min	<1 hour	45 min	50 min	50 min	50 min	50 min	50 min	50 min	50 min	
2. System bakeout	200 °C 26 hours	200 °C 15 hours	200 °C 21 hours	200 °C 24 hours	200 °C 15 hours	200 °C 9 hours	200 °C 18 hours	200 °C 15 hours	200 °C 24 hours	200 °C 17 hours	200 °C 20 hours	
3. Degas	Degas SIP, BAGx3, RGAx2 NEG C1300 activation (500 °C, 45 min)				RGA1	RGA1	Degas SIP, BAG, RGA NEG C1300 activation	RGA1	RGA1	Degas SIP, BAG, RGA NEG C1300 activation	Degas SIP, BAG, RGA NEG C1300 activation	
4. NEG coating activation	250 °C 24 hours	250 °C 24 hours	250 °C 24 hours	250 °C 24 hours	250 °C 24 hours	250 °C 24 hours	250 °C 24 hours	250 °C 24 hours	250 °C 24 hours	250 °C 24 hours	-	
5. Cool down	Cool down to room temperature				Cool down to room temperature				Cool down to room temperature			
6. SR irradiation	3.6 days 9.9x10 <sup>21</sup> ph/m	3.5 days 1.1x10 <sup>22</sup> ph/m	5.4 days 1.5x10 <sup>22</sup> ph/m	4.4 days 1.4x10 <sup>22</sup> ph/m	-	-	8.8 days 3.3x10 <sup>22</sup> ph/m	-	-	7.8 days 2.6x10 <sup>22</sup> ph/m	4.9 days 1.8x10 <sup>22</sup> ph/m	
					NO SR irradiation			NO SR irradiation			No NEG activation	

# 4 – Application to synchrotrons light sources

What is the required thickness? => minimize beam impedance

What is the evolution of the PSD from a 200 nm film in function of venting/activation cycles?

**Photon stimulated desorption yield**

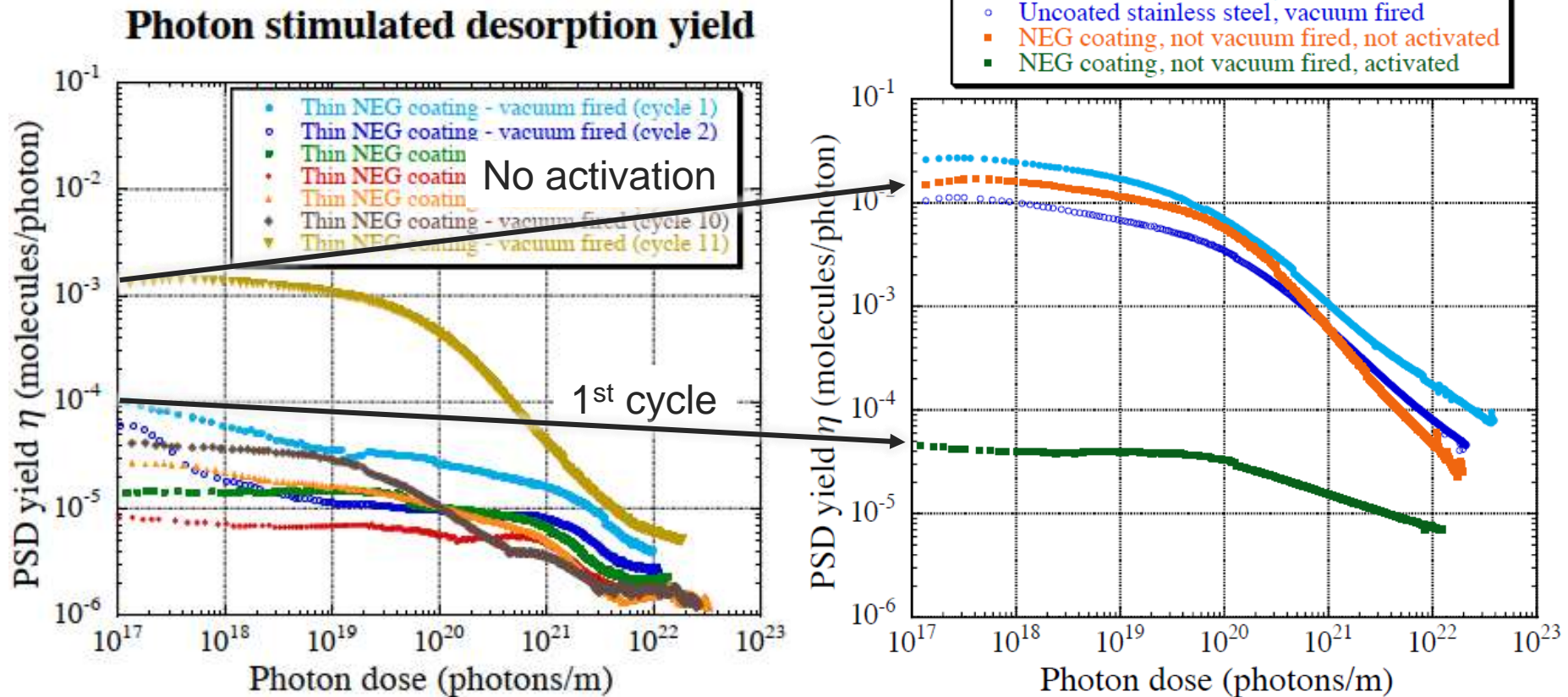


- PSD decrease with venting/activation/irradiation cycles
- PSD increase slightly if no irradiation
- PSD without activation gets better!

# 4 – Application to synchrotrons light sources

What is the required thickness? => minimize beam impedance

What is the evolution of the PSD from a 200 nm film in function of venting/activation cycles?



# 5 – Summary & final remarks

- NEG coatings can provide **distributed pumping speed** and **low PSD**, (and in addition low Secondary Electron Yield), and are now present in several kilometres of accelerators beam pipes all around the world.
- **Sputtering** have proven high “versatility”, allowing to coat chambers with apertures ranging from 500 mm to 6 mm and different geometries.
- **Thickness uniformity**: at CERN, coating beam pipes with apertures down to 6 mm is still not fully mastered. Optimization requires the change of “standard” parameters... or the fabrication process of the chamber (“inverse NEG”)
- **Minimum thickness**: down to 200 nm, the NEG is robust against air venting/activation cycles (tested up to 10; always goes down after irradiation). Thinner to be tested...
- **Adhesion** (no tackled): **surface treatment** before coating is **crucial!**

**NEVER DISREGARD THE SURFACE TREATMENT**



Thank you 😊